
InstrumentStudio

User Manual



dataTec

Mess- und Prüftechnik. Die Experten.

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InstrumentStudio User Manual

The InstrumentStudio User Manual provides detailed descriptions of the product functionality and the step by step processes for use.

Looking for Something Else?

For information not found in the User Manual for your product, such as specifications and API reference, browse ***Related Information***.

Related information:

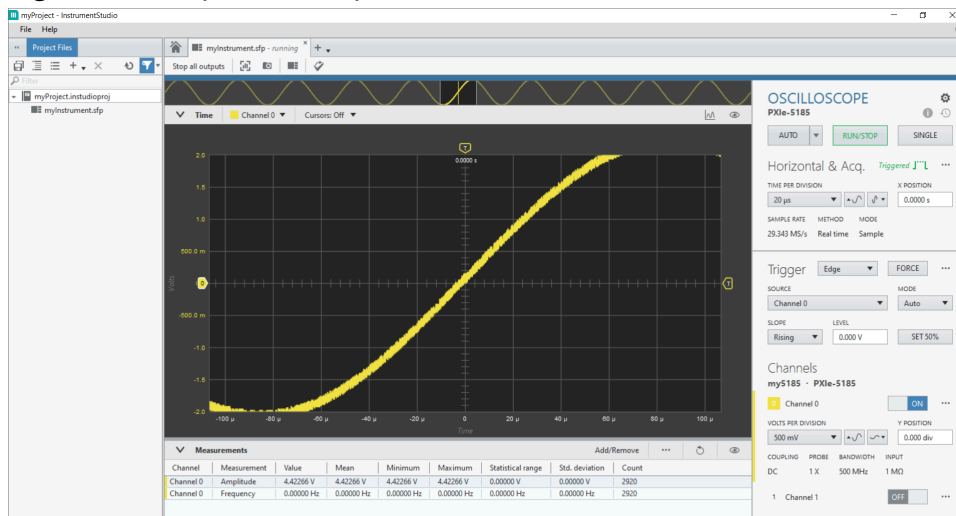
- [Download InstrumentStudio](#)
- [License Setup and Activation](#)

Navigating InstrumentStudio

Learn about the InstrumentStudio UI and InstrumentStudio project file structure so you can quickly create projects.

Overview

Figure 1. Example of a Scope instrument



Project File Pane

The project file panel displays all project files, such as the following:

- Data files
- Saved configurations
- Scripts
- Pin maps
- Other supporting files

The project file panel also allows for the following file management actions:

- Create
- Rename
- Delete
- Import
- Export

- Search

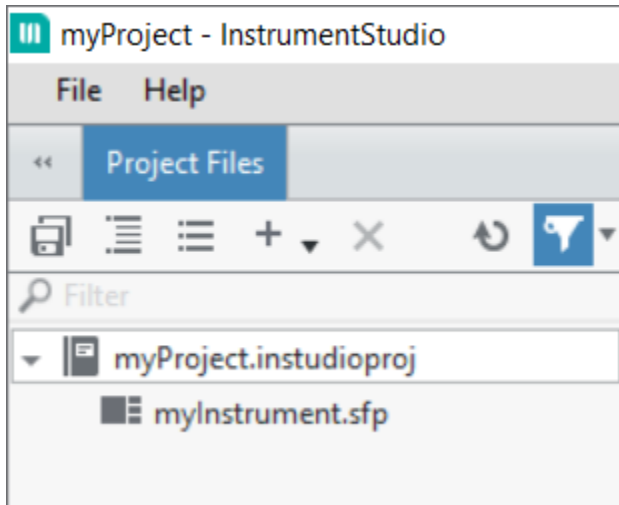


Table 1. InstrumentStudio Project File Documents

File Type	Description
InstrumentStudio project (.isproj)	Contains the instrument panels added to your layout, device configurations, pin maps, captured data, and other project files.
Soft front panel (.sfp)	Contains the settings you choose for each instrument in your layout.
Pin map (.pinmap)	Defines how instruments and hardware connect to device under test (DUT) pins and sites.
Technical Data Management Stream (.tdms)	Stores data created by taking a snapshot of a graph. InstrumentStudio saves these files by default in the folder that contains your project.
Portable Network Graphic (.png)	An image of a graph created by taking a snapshot. InstrumentStudio saves these files by default in the folder that contains your project.

Measurement Table

The measurement table panel allows you to quickly set up and perform common measurement tasks, such as the following:

- Measure signal properties
- Analyze signal characteristics
- Perform stimulus response tests

Measurements								
Add/Remove								
Channel	Measurement	Value	Mean	Minimum	Maximum	Statistical range	Std. deviation	Count
Channel 0	Amplitude	4.42266 V	4.42266 V	4.42266 V	4.42266 V	0.00000 V	0.00000 V	2920
Channel 0	Frequency	0.00000 Hz	0.00000 Hz	0.00000 Hz	0.00000 Hz	0.00000 Hz	0.00000 Hz	2920

Instrument Configuration

The instrument configuration panel allows you to configure instrument settings and view instrument status.

OSCILLOSCOPE

PXIe-5185

⚙️
ℹ️
🕒

AUTO ▾

RUN/STOP

SINGLE

Horizontal & Acq. Triggered J...L ...

TIME PER DIVISION

20 μ s ▾

⬆️
⬆️
⬆️

X POSITION

0.0000 s

SAMPLE RATE

29.343 MS/s

METHOD

Real time

MODE

Sample

Trigger

Edge ▾

FORCE

...

SOURCE

Channel 0 ▾

MODE

Auto ▾

SLOPE

Rising ▾

LEVEL

0.000 V

SET 50%

Channels

my5185 · PXIe-5185

0 Channel 0

ON

...

VOLTS PER DIVISION

500 mV ▾

⬆️
⬆️
⬆️

Y POSITION

0.000 div

COUPLING

DC

PROBE

1 X

BANDWIDTH

500 MHz

INPUT

1 M Ω

1 Channel 1

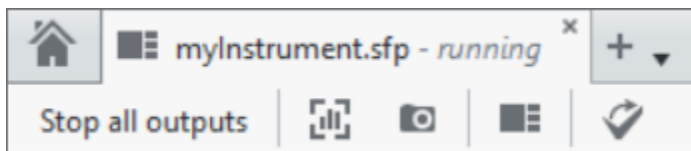
OFF

...

Instrument Header Menu

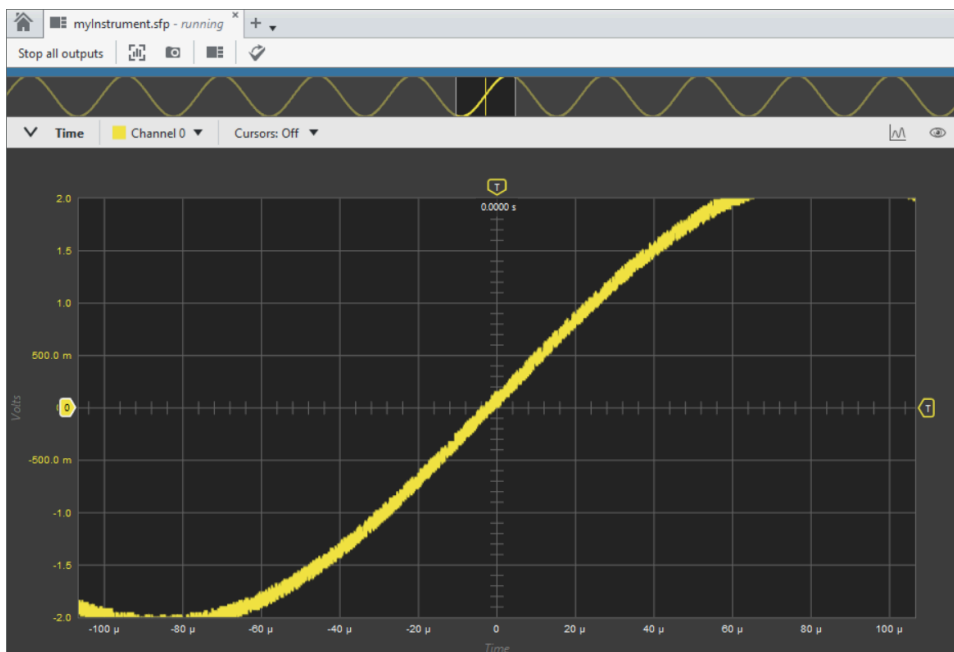
The instrument header menu allows you to perform the following actions:

- Create new instrument panels
- Capture data and screenshots
- Edit layouts
- Export to TestStand



Measurement Graphs

The measurement graphs panel allows you to visualize data from connected instruments and interact with the graph. You can zoom, pan, and create annotations in the graphs.



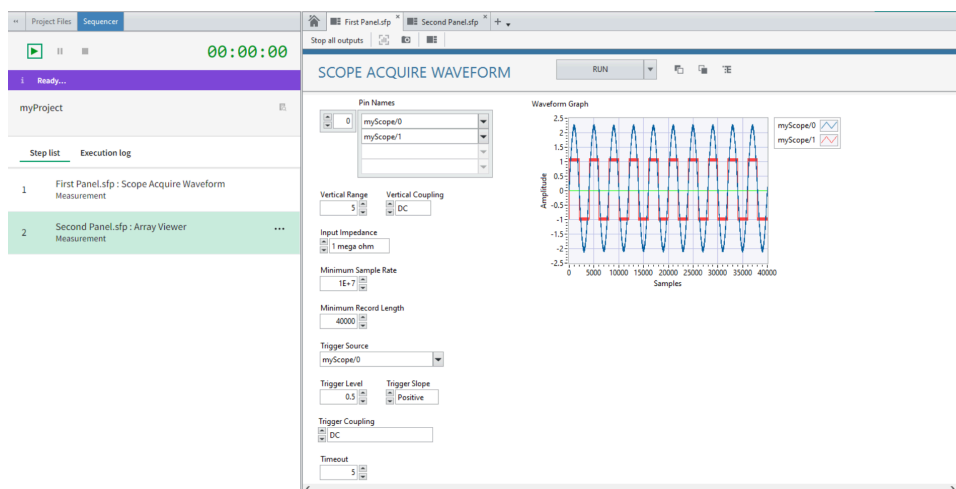
Sequencer Tool



Note This feature is only available with an InstrumentStudio Professional license.

The sequencer tool allows you to do the following tasks:

- Create and modify measurement sequences
- View measurement panels associated with sequence steps
- View a log that details the results of executing a sequence



Related information:

- [NI TDMS File Format - What is a TDMS File?](#)

InstrumentStudio New Features and Changes

Learn about updates, including new features and behavior changes, introduced in each version of InstrumentStudio.

Discover what is new in the latest releases of InstrumentStudio.



Note If you cannot find new features and changes for your version, it might not include user-facing updates. However, your version might include non-visible changes such as bug fixes and compatibility updates. For information about non-visible changes, refer to your product **Release Notes**.

Related information:

- [Download InstrumentStudio](#)
- [License Setup and Activation](#)

2025 Q4

October 2025

Oscilloscopes

- Added support for specifying the measurement units (in volts or amperes) of a connected probe.

RF Signal Generator

- Added support for additional file types for arbitrary waveform generation.
- Added support for editing script content when operating in Script mode.
- The use of Script mode is no longer limited to debugging an external session.

🔑 Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Sequencer Tool
 - Added support for the Network Analyzer panel type.
 - Added support for parameter sweeps in RF Signal Analyzer steps.
 - Added support for parameter sweeps in RF Signal Generator steps.

Related concepts:

- [Sequencer Tool](#)

Related reference:

- [RF Signal Generators](#)
- [Oscilloscopes](#)

Related information:

- [Measurement Plug-In User Manual](#)

2025 Q3

July 2025

Added support for in-product calibration without Measurement and Automation Explorer (MAX).

Network Analyzer

- Added support for CW time sweep.
- Added group delay trace.

RF Signal Analyzer (RFmx)

- Added support for importing .s2p files to facilitate the configuration of the Noise

Figure measurement.

SMU/Power Supply

- The PXIe-4051 now supports power and resistance channel operating modes.

Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Measurement Plug-Ins
 - Added support for the "1D array of XY data" data type for measurement plug-ins.
- Sequencer Tool
 - Added support for the RF Signal Analyzer panel type.
 - Added support for the RF Signal Generator panel type.
 - Added support for single-channel sweep and two-channel sweep modes to sequences on DC power instrument panels.

Related concepts:

- [Sequencer Tool](#)

Related reference:

- [Network Analyzers](#)
- [RF Signal Analyzers](#)

Related information:

- [Measurement Plug-In User Manual](#)

2025 Q2

April 2025

- All instrument panels can be upgraded without upgrading the corresponding

driver of the instrument panel. InstrumentStudio 2025 Q2 supports the same driver versions that were supported by InstrumentStudio 2025 Q1.

Network Analyzer

- Added support for trace math.
- Added marker enhancements, including target search and continuous marker mode.
- Added auto-detection of orientation for electronic calibration.

🔑 Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Sequencer Tool
 - Added support for parameter sweeps in instrument steps.
 - Added support for SCPI instruments (third-party instruments) in sequences.

Related concepts:

- [Sequencer Tool](#)

2025 Q1

January 2025

Network Analyzer

- Added support for markers.
- Added support for memory traces.

RF Signal Analyzer (RFmx)

- Spectrum Analyzer - Added frequency counter measurement.
- LTE - Added support for downlink NB-IoT.
- Bluetooth - Added new trace and results for HDT.

RF Signal Generator

- Added the ability to change the active script while debugging test code in script mode.
- Added the ability to switch to CW (continuous waveform) or Arb (arbitrary waveform) mode while debugging test code in script mode.

Oscilloscope

- Enhanced monitoring support- vertical scaling will be automatically updated based on test program settings.
- Added support for all PXIe-5172 onboard timebase rates.

🔑 Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Sequencer Tool
 - Added support for native instrument types- FGEN, SCOPE, and SMU/VPS panels can now be added to sequences.
 - Added support for parameter sweeps in measurement plug-in steps.
- Measurement Plug-Ins
 - Added support for parameter sweeps for measurement plug-ins.

Updates and Changes for InstrumentStudio Extended Support Versions

Browse updates and changes made in InstrumentStudio versions on extended support.



Note If you cannot find changes for your version, it might be a more recent version, documented as a new feature. Or, your version might not have included user-facing updates. You can find more information about non-visible changes, such as bug fixes, compatibility updates, and stability adjustments or maintenance adjustments, in the product **Release Notes**, available on ni.com.

2024 Q4

October 2024

- Added segmented sweeps to the Network Analyzer instrument as well as enhancements to pulsed S-parameters, data visualizations, and calibration.
- Added channel merging capability to the SMU/Power Supply instrument to allow combining multiple channels to achieve a higher output current.

🔑 Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Added support for SCPI-capable oscilloscopes.
 - Fetch data and screenshot captures from SCPI instruments.
 - Fetch configurations from SCPI instruments.
 - Apply configurations to SCPI instruments.

Refer to **SCPI Instrument Panels** for more information on using SCPI-capable devices with InstrumentStudio.

- Sequencer Tool

- Added support for digital multimeters in the Sequencer Tool. You can now create steps to read measurements from supported digital multimeters.
- Added support for wait steps. You can now create wait steps in your sequences.
- UI improvements to the sequencer tool. You can now view steps associated with measurement panels.
- Measurement Plug-Ins
 - Added support for measurement plug-in versioning. Refer to the ***Measurement Plug-In User Manual*** for more information measurement plug-in versioning.
 - Added support for displaying a link to measurement plug-in documentation in InstrumentStudio and TestStand

Related concepts:

- [SCPI Instrument Panels](#)

Related information:

- [Measurement Plug-In User Manual](#)

2024 Q3

July 2024

- Pin maps are no longer required use measurement plug-ins.
- Added several enhancements to the Network Analyzer instrument, including the ability to save S-parameter measurement results to Touchstone format (.snp) files.
- Added band power markers to the Spectrum measurement in the RF Signal Analyzer instrument.

🔑 Professional License Only

The following new features are only available with an InstrumentStudio Professional license.

- Added support for measurement plug-ins. Refer to the ***Measurement Plug-Ins***

user manual for more information on developing measurements.

- Added the Sequencer Tool for sequencing measurements using measurement plug-ins.
- Added support for connecting to plug-in libraries.

Related concepts:

- [Sequencer Tool](#)

Related tasks:

- [Connecting to a Plug-In Library](#)

Related information:

- [Measurement Plug-In User Manual](#)

2024 Q2

April 2024

- Added manual calibration, pulse mode, triggering, and improved calset support to the Network Analyzer instrument.
- Reference waveform and de-embedding file paths are now stored with the RF Signal Analyzer configuration, allowing for automatic reload.
- Added several enhancements for Channel Sounding packets using the RF Signal Analyzer Bluetooth personality.

2024 Q1

January 2024

- Added support for Fixed Markers using RF Signal Analyzer instruments.
- Added custom bitfile support for RF Signal Analyzer and RF Signal Generator instruments.

2023 Q4

October 2023

- You can now undo and redo changes made to panel properties.
- Improved searching and filtering of instruments and measurements in the Edit Layout window.
- Use the new Network Analyzer instrument to control supported NI vector network analyzers.
- Added support for capturing IQ data using the RF Signal Analyzer instrument.
- Added support for Channel Sounding packets using the RF Signal Analyzer Bluetooth personality.
- Added several enhancements to the RF Signal Analyzer Pulse personality, including support for multi-burst analysis and phase and frequency traces.

2023 Q3

July 2023

- Added full support for remote RF Signal Analyzer panel for SpecAn, LTE, NR, WLAN and Bluetooth personalities (no longer preview features).
- Added Bluetooth personality to remote RF Signal Analyzer panel.
- Added new remote connections section in the preferences menu.
- Added support for pulse measurements in the RF Signal Analyzer panel.

Related information:

- [Remote RF Signal Analyzer Panel](#)
- [Managing Remote Connection Preferences](#)

2023 Q2

April 2023

- Added LTE, NR, and WLAN personalities to remote RF Signal Analyzer panel preview feature.



Note Preview features have limited functionality and are not fully supported.

Related information:

- [Remote RF Signal Analyzer Panel](#)

2023 Q1

January 2023

- Added SMU measurement auto-range support for PXIe-4190 and PXIe-4190 (500 kHz).
- Added LCR Meter impedance measurement auto-range support in sweep mode.
- Added remote RF Signal Analyzer panel viewing as a preview feature.



Note Preview features have limited functionality and are not fully supported.

Related information:

- [SMU Measurement Autorange](#)
- [Enabling Preview Features](#)
- [Remote RF Signal Analyzer Panel](#)

2022 Q4

October 2022

- Added oscilloscope **Manual Override** mode, enabling simultaneous manual configuration of Record length and Sample Size in oscilloscope settings .

Related information:

- [Setting Sample Rate and Record Length Manually](#)

2022 Q3

July 2022

- SMU measurement auto-range support for DC Power devices that support it.
- Single-channel sweep mode support for PXIe-4190 when used in LCR mode.
- LCR Meter mode usability improvements for PXIe-4190.
- RF Signal Analyzer instrument with support for RFmx personalities.

Related information:

- [SMU Measurement Autorange](#)
- [SMU/VPS Modes of Operation](#)
- [Analyzing RF Signals with an RF Signal Analyzer](#)

2022 Q2

April 2022

- Single-channel sweep mode measurement added as a preview feature for PXIe-4190 when used in LCR mode.

2022 Q1

January 2022

- LCR panel debug monitor functionality and usability improvements for the LCR PXIe-4190 module.
- Custom gating support for Scope measurements.

Related information:

- [Customizing Oscilloscope Measurements](#)

2021 Q4

October 2021

- Added new LCR panel supporting interactive use with the PXIe-4190 module.
- Added access and visibility to pin maps.
- Improved UI responsiveness and added pin filtering for systems with high channel counts.

Related information:

- [SMU/VPS Modes of Operation](#)
- [Setting an Active Project Pin Map](#)

2021

April 2021

- Added new RFSG Signal Generator panel supporting interactive use and debugging using PXIe-5820, PXIe-5830, PXIe-5831, PXIe-5832, PXIe-5840, and PXIe-5841.
- Added support for the PXIe-4135(40W) and PXIe-4137(40W) source measure unit, newly supported in NI-DCPOWER 20.7.

Related information:

- [Generating RF Signals with an RF Signal Generator](#)

2020

November 2020

- Added support for the PXIe-4139(40W) source measure unit, newly supported in NI-DCPower 20.5.
- Added support for multichannel session in the SMU/Power Supply panel, newly supported in NI-DCPower 20.6. Initializing an NI-DCPower session with independent channels allows you to use multiple instruments in the same session. With independent channels, you can configure multiple channels of the same instrument, or of multiple instruments independent of one another within the same session.
- Added support for monitoring merged channels in debug mode on the PXIe-4147. Merged channels are newly supported in NI-DCPower 20.6. Merging channels of an NI SMU allows you to use multiple channels in unison to increase the current you

can source beyond the normal maximum for a single SMU channel.

Related information:

- [NI-DCPower Independent Channel Sessions](#)

2019 SP1

May 2020

- Added support for the PXIe-4147 source measure unit, newly supported in NI-DCPower 20.0.

2019

September 2019

- Multiple NI-SCOPE devices of the same model can now be synchronized in the same oscilloscope panel.
- Added support for selecting trigger sources and events from other NI devices in your system.
- Added waveform graphing, pulse current, pulse voltage, voltage sequence, and current sequence modes to SMU panels, including automatic hardware synchronization across multiple devices.
- Added asymmetric limits and software-protected ranges to SMU/Power Supply panels.
- Added NI-DCPower SourceAdapt configuration to SMU panels, useful for transient measurements.
- Added channel views to hide idle channels, show power calculations, and condense channel views to the SMU/Power Supply panels.
- Added inductance and capacitance measurements along with open and short cable compensation to digital multimeter (DMM) panels.
- Added the ability to generate waveforms from binary files to the waveform generator panel.
- Added debugging and monitoring support to the waveform generator panel.
- Added exporting configuration files from the waveform generator panel for use with the NI-FGEN driver.

- Added capability to export device configurations to TestStand for use in test step configuration.
- Added ability to use pin maps created in Digital Pattern Editor to group devices and channels by site and use pin names for channel aliases.

Related information:

- [SMU/VPS Modes of Operation](#)
- [Configuring SourceAdapt Parameters to Measure Transients](#)
- [Performing Cable Compensation](#)
- [Generating Waveforms with a Waveform Generator](#)
- [Exporting a Device Configuration](#)
- [Exporting Configurations to TestStand](#)
- [Pin Maps](#)

2018 SP2

January 2019

- Added support for the PXIe-5163 oscilloscope, newly supported in NI-SCOPE 18.7.
- Added CSV file format for data capture.
- Added support for exporting instrument events to PXI chassis trigger lines.
- Added support for arbitrary waveform generation mode to the Waveform Generator panels.
- Added support for frequency list and sweep modes to the Waveform Generator panels.
- Added FFT channels, frequency markers, and FFT channel measurements to the Oscilloscope panels.
- Added additional 2-channel measurements to the Oscilloscope panels.

Related information:

- [Capturing Data](#)
- [Waveform Modes](#)
- [Adding FFT Channels and Markers](#)

2018 SP1

September 2018

- Added support for the PXIe-5110, PXIe-5111, and PXIe-5113 oscilloscopes, newly supported in NI-SCOPE 18.6.

2018

May 2018

- This was the initial release of InstrumentStudio.

Supported Hardware

The following tables list hardware that can be used with InstrumentStudio, and the first available version of InstrumentStudio to support the hardware.

NI-DCPower

The following NI-DCPower hardware can be used with a SMU/Power Supply instrument in InstrumentStudio.

Model Name	First Available
PXIe-4150	2024
PXIe-4151	2023
PXIe-4051	2023
PXIe-4112	2018
PXIe-4113	2018
PXIe-4135	2018
PXIe-4135 (40W)	2021
PXIe-4136	2018
PXIe-4137	2018
PXIe-4137 (40W)	2021
PXIe-4138	2018
PXIe-4139	2018
PXIe-4139 (40W)	2020
PXIe-4140	2018
PXIe-4141	2018
PXIe-4142	2018
PXIe-4143	2018
PXIe-4144	2018

Model Name	First Available
PXIe-4145	2018
PXIe-4147	2019 SP1
PXIe-4154	2018
PXIe-4162	2018
PXIe-4163	2018
PXIe-4190 ¹	2021 Q4
PXIe-4190 (500 kHz) ¹	2022 Q3
PXI-4110	2018
PXI-4130	2018
PXI-4132	2018
¹ The PXIe-4190 and PXIe-4190 (500 kHz) can be used with either an SMU/Power Supply instrument or an LCR meter in InstrumentStudio	

NI-DMM

The following NI-DMM hardware can be used with a Digital Multimeter instrument in InstrumentStudio.

Model Name	First Available
PXIe-4080	2018
PXIe-4081	2018
PXIe-4082	2018
PXI-4065	2018
PXI-4070	2018
PXI-4071	2018
PXI-4072	2018
PCIe-4065	2018

Model Name	First Available
PCI-4065	2018
USB-4065	2018
PCI-4070	2018

NI-FGEN

The following NI-FGEN hardware can be used with a Waveform Generator instrument in InstrumentStudio.

Model Name	First Available
PXIe-5413 (1-channel)	2018
PXIe-5413 (2-channel)	2018
PXIe-5423 (1-channel)	2018
PXIe-5423 (2-channel)	2018
PXIe-5433 (1-channel)	2018
PXIe-5433 (2-channel)	2018
PXIe-5442	2018
PXIe-5450	2018
PXIe-5451	2018
PXI-5402	2018
PXI-5404	2018
PXI-5406	2018
PXI-5412	2018
PXI-5421	2018
PXI-5422	2018
PXI-5441	2018
PCI-5402	2018
PCI-5406	2018

Model Name	First Available
PCI-5412	2018
PCI-5421	2018

NI-SCOPE

The following NI-SCOPE hardware can be used with an Oscilloscope instrument in InstrumentStudio.

Model Name	First Available
PXle-5105	2018
PXle-5110	2018
PXle-5111	2018
PXle-5113	2018
PXle-5113	2018
PXle-5122	2018
PXle-5160 (2-channel)	2018
PXle-5160 (4-channel)	2018
PXle-5162 (2-channel)	2018
PXle-5162 (4-channel)	2018
PXle-5163	2018 SP2
PXle-5164	2018
PXle-5170 (4-channel)	2018
PXle-5170 (8-channel)	2018
PXle-5171 (8-channel)	2018
PXle-5172 (4-channel)	2018
PXle-5172 (8-channel, 325T)	2018
PXle-5172 (8-channel, 410T)	2018
PXle-5185	2018

Model Name	First Available
PXIe-5185 (1M Ω)	2018
PXIe-5186	2018
PXIe-5186 (1M Ω)	2018
PXIe-5622	2018
PXIe-5622 (DD)	2018
PXI-5105	2018
PXI-5114	2018
PXI-5122	2018
PXI-5124	2018
PXI-5142	2018
PXI-5152	2018
PXI-5153	2018
PXI-5154	2018
PXI-5922	2018
PCI-5105	2018
PCI-5114	2018
PCI-5122	2018
PCI-5124	2018
PCI-5142	2018
PCI-5152	2018
PCI-5153	2018
PCI-5154	2018
PCI-5922	2018
PCIe-5155	2018
USB-5132	2018
USB-5133	2018

NI-RFSG

The following NI-RFSG hardware can be used with a RF Signal Generator instrument in InstrumentStudio.

Model Name	First Available
PXIe-5820	2021
PXIe-5830	2021
PXIe-5831	2021
PXIe-5832	2021
PXIe-5840	2021
PXIe-5841	2021
PXIe-5842	2022

NI-RFSA

The following NI-RFSA hardware can be used with a RF Signal Analyzer instrument in InstrumentStudio.

Model Name	First Available
PXIe-5644	2022 Q3
PXIe-5645	2022 Q3
PXIe-5646	2022 Q3
PXIe-5663	2022 Q3
PXIe-5663E	2022 Q3
PXIe-5665	2022 Q3
PXIe-5668	2022 Q3
PXIe-5668 with PXIe-5698	2022 Q3
PXIe-5820	2022 Q3
PXIe-5830	2022 Q3

Model Name	First Available
PXIe-5831	2022 Q3
PXIe-5832	2022 Q3
PXIe-5840	2022 Q3
PXIe-5841	2022 Q3
PXIe-5842	2022

Configuring Panels and Layout

Adjust the arrangement of soft front panels and their associated devices with the Edit Layout window.

An InstrumentStudio layout consists of one large panel and up to four small panels. A large panel includes a measurement graph and is located in the center of the screen. Small panels feature channel settings and are located on the right sidebar. You can also combine multiple devices of the same type into a single panel.

Layouts in InstrumentStudio must meet the following requirements:

- The layout must have exactly one large panel.
- You can place oscilloscopes only in a large panel. Only oscilloscopes of the same model may be added to the same panel.
- The layout can have up to four small panels. Small panels are not required.

Creating a Layout

Before you can take measurements and monitor devices in InstrumentStudio, you must create a layout. Create a layout from the Home screen, from the document toolbar, or from any instrument header menu.

Creating a Layout Automatically

When you create a layout automatically, InstrumentStudio detects devices you have installed and creates panels using those devices. Complete the following steps to create an automatic layout in InstrumentStudio:



Note You can edit an automatic layout at any time by choosing **Add/Remove devices** from the instrument header menu. Opening the Edit Layout window using **Add/Remove devices** automatically filters the device list based on the type of panel you selected Add/Remove devices from. Remove or change the filter using the drop-down menu in the upper left corner.

1. Install the devices you would like to use and make sure they appear in the Hardware Configuration Utility or Measurement & Automation Explorer (MAX).
2. Open InstrumentStudio.
3. Select **Auto Create Layout** from the Home screen.

InstrumentStudio creates a large or small panel for each compatible device installed in the system.

Creating a Layout Manually

You can use the Edit Layout window to create a manual layout. In a manual layout, you can customize which devices are displayed and group devices of the same type into a single panel.

Refer to [Configuring Panels and Layout](#) to learn more about layout rules and restrictions.

Complete the following steps to create or edit a manual layout:

1. Access the Edit Layout window in one of three ways:
 - From the Home screen, select **Manual Layout**.
 - From any instrument header menu, select **Add/Remove devices**.



Note

- Opening the Edit Layout window using **Add/Remove devices** automatically filters the device list based on the type of panel you selected **Add/Remove devices** from. Remove or change the filter using the drop-down menu in the upper left corner.
- Only oscilloscopes of the same model may be added to the same panel.

- From the document toolbar, select the **Edit layout** icon (■).
2. Search for the device(s) you would like to include in the layout in the left panel of the Edit Layout window. You can filter by device type using the drop-down menu in the upper left corner.
 3. Add the device to a panel by selecting either **Create large panel** or **Create small panel** from the device's drop-down menu.
The device is displayed in the panel you select.



Note You can remove a device from a panel by clicking the × to the right of the device's name.

4. (Optional) Once a panel is created, you can group devices of the same type together in a single panel by selecting the group name from a device's drop-down menu.
5. Select **OK** to create the layout you specified.

You have created a manual layout.

Related concepts:

- [Configuring Panels with the Instrument Header Menu](#)

Configuring Panels with the Instrument Header Menu

The instrument header menu in InstrumentStudio offers options for data management, device configuration, and panel controls.

Each panel in InstrumentStudio has its own instrument header menu. Click the instrument header menu icon (⚙️) in the upper-right corner of the panel to access the instrument header menu. From the instrument header menu, you can select the following options:

- **Capture data**—Saves a timestamped screenshot and an NI-TDMS file containing a data snapshot. For more information, see ***Capturing Data***.
- **Export configuration**—Saves model-specific configuration files to a specified folder. You can import a configuration file to LabVIEW to apply the device's configuration to a different device session. For more information, see ***Exporting a Device Configuration***.
- **[Device name]**—Opens options for the specified device. From this menu, you can remove the device from the panel, relink devices, and access the device's documentation.
- **Add/Remove devices**—Opens the **Edit Layout** window. For more information, see ***Creating a Layout***.
- **Configure debug session**—Opens the **Configure Debug Session** window, which you can use to enable and disable debugging on devices. For more information,

see ***Debugging Programmatic Applications***.

- **Launch in new tab**—Opens the panel in a new tab with the same configuration.
- **Delete panel**—Removes the panel from the layout.

Related concepts:

- [Capturing Data](#)
- [Debugging Programmatic Applications](#)

Related tasks:

- [Creating a Layout Manually](#)
- [Enabling Debugging with a C, C++, or .NET Application](#)
- [Exporting a Device Configuration](#)
- [Relinking or Replacing Missing Devices](#)

Relinking or Replacing Missing Devices

Use relinking to re-establish a connection to a missing device. You can also use relinking to replace the missing device with a different device of the same model in an existing panel.

InstrumentStudio flags devices as missing if InstrumentStudio is closed and a device used in an InstrumentStudio project goes offline or has its name changed. The next time you open the project, the title bar of the panel is gray instead of blue. The panel also displays a "Missing hardware" message. The caution icon (⚠) appears over the instrument header menu of the affected panel and next to the missing device inside the instrument header menu. InstrumentStudio also notifies you of the missing device in the Edit Layout window.

Relink a missing device through the instrument header menu, or **replace** a missing device in the Edit Layout window. When you relink a missing device through the instrument header menu, InstrumentStudio applies the existing configuration of the device to the relinked device. You can replace a missing device through the Edit Layout window. In this case, InstrumentStudio discards the existing device configuration and creates another configuration for the replacement device.



Note You can also relink or locate a missing device through the Hardware Configuration Utility (HWCU) or Measurement & Automation Explorer (MAX). If InstrumentStudio is open, changes made in HWCU or MAX are automatically applied to InstrumentStudio panels. If a device went missing because it was renamed while InstrumentStudio was closed, relink the missing device. To relink the missing device, open the InstrumentStudio panel that contains the missing device. Then, change the name of the device in HWCU or MAX to match the name that InstrumentStudio is looking for.

Relinking Missing Devices from the Instrument Header Menu



Note You can use this method to link a different device of the same model to an existing panel, even if the original device is not missing. Replacing a device in a panel through relinking preserves device settings from the original device and applies these settings to the replacement device.

1. Open the instrument header menu of the panel (⚙️) with the missing device.
2. Select the missing device. The missing device has a caution icon (⚠️) next to it.
3. Select **Relink**.
4. Select the name of the device that you want to link to the panel.



Note When relinking from the instrument header menu, the relinked device must be the same model as the missing device. InstrumentStudio applies the existing device configuration to the new device when it is linked.

5. Select **Run** on the relinked panel.

You relinked the missing device (or a device of the same model) to the panel.

Replacing Missing Devices from the Edit Layout Window

You cannot directly relink a missing device from the Edit Layout window. To remove a missing device and replace it with a different device, perform the following steps:

1. Open the Edit Layout window in one of two ways:
 - From the document toolbar, select the **Edit layout** icon (📐).

- From any instrument header menu, select **Add/Remove devices**.



Note Opening the Edit Layout window through **Add/Remove devices** automatically filters the device list based on the type of panel you selected **Add/Remove devices** from. For best results, select **Add/Remove devices** from the panel that contains the device you want to replace.

2. Locate the missing device. The missing device has a caution icon (⚠) next to it.
3. Select the × next to the caution icon to remove the missing device from the layout.



Note If the missing device was not part of a group, removing the device also removes the panel of the device.

4. Add a replacement device of the same type to the panel (if adding to a group), or make a new panel with the replacement device.





Note When replacing missing devices from the Edit Layout window, the new device must follow the same InstrumentStudio layout guidelines as any other device. Refer to [Configuring Panels and Layout](#) for more information on layout guidelines.

5. Select **OK** to save your changes.
6. Select **Run** on the edited panel.

Multi-Device Synchronization

In InstrumentStudio, device synchronization generally falls under two categories: software and hardware.

Software Synchronization	Hardware Synchronization
	
Channel acquisition and generation is sequenced in software.	Channel acquisition and generation is sequenced in hardware.
There is no strict timing guarantee between channels.	There is a strict timing guarantee between channels.

Panel Synchronization



The different panels within InstrumentStudio support various levels of device and channel synchronization:

DMM—All channels are always software synchronized.

Waveform generators—All channels are software synchronized by default.



Note Channels within a 2-channel PXle-5450 or PXle-5451 waveform generator are always hardware synchronized.

- All channels on a single device are always hardware synchronized.
- All channels within a single panel are hardware synchronized if every device is the same model and is in the same chassis. Channels across different physical devices are synchronized with [NI-TCI technology](#).
- You can also trigger an oscilloscope from another instrument in the system by configuring a digital trigger and selecting the source based on the device name.
- Every channel configured for a sequence or pulse generation within a single SFP are automatically hardware synchronized. You can configure routing options by selecting the  icon.
- Channels are software synchronized () in all other cases.
- You can also trigger an SMU from another instrument in the system by configuring a digital trigger and selecting the source based on the device name.

The following details apply to RFSG, RFSA, and Network Analyzer instruments.

- You can only have one device in a single panel.
- Devices cannot be synchronized.

Remote RF Signal Analyzer Panel

This section describes how to add a remote RF Signal Analyzer to your project to use remote RFmx hardware.

The following list describes important limitations to be aware of while using remote RF

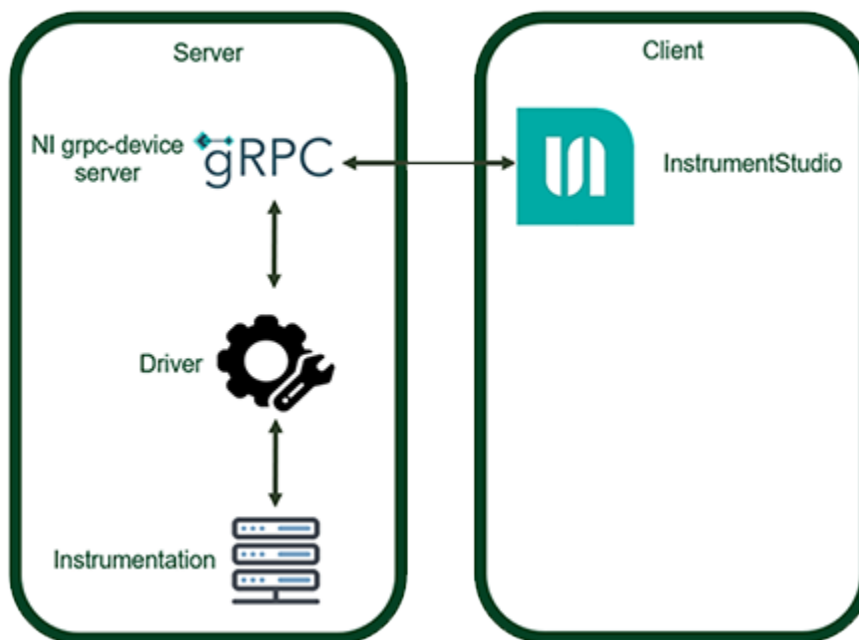
panels.

- Spectrum Analyzer, LTE, WLAN, Bluetooth, and NR personality are the only available personalities in remote Signal Analyzer panels.
- Remote hardware must be present on the same network in order to be remotely connected.
- Remote panels perform best when the remote hardware is within your local facility topology.
- You cannot create a remote panel for a device that is in use by another remote client.
- You cannot remotely monitor a remote session hosted on another client.

Overview of Remote Panel Connections

Remote panel connections are facilitated by the NI gRPC server. You do not need to install NI drivers on the client you use to remotely access an RF panel. All required drivers must be installed on the server which hosts the hardware.

Figure 2. gRPC Server-Client Architecture



Refer to ***Configuring Your System for Remote RF Signal Analyzer Panels*** for more information

- [Adding a Remote RFmx Panel to Your Layout](#)

- [Configuring Your System for Remote RF Signal Analyzer Panels](#)

Configuring Your System for Remote RF Signal Analyzer Panels

You must configure a gRPC server before remotely connecting to RF Signal Analyzer hardware using InstrumentStudio. The server must be set up on the computer that is connected to the hardware. Complete the following steps to enable remote connections to RF Signal Analyzer hardware.

1. Go to the [NI gRPC device repo](#) and follow the instructions there to install the NI gRPC server on the computer connected to the hardware.
2. Navigate to the install location, and open the `server_config.json` file in an editor.
3. Add the following parameter and value to your configuration file:
`"code_readiness": "RestrictedRelease"`
4. Remove the line `"address" : "[::1]"`. This allows any address to connect to the device.
5. Update the port number. This will require users to specify a port number when connecting from InstrumentStudio.
6. Run the server. Follow instructions in the [NI gRPC device repo](#) for specific instructions on running the server.

Your configuration file should now look like this:

```
{
  "port": 31763,
  "security" : {
    "server_cert": "",
    "server_key": "",
    "root_cert": ""
  },
  "code_readiness": "RestrictedRelease"
}
```

Your system is now configured to allow clients to create [remote Signal Analyzer panels](#) in InstrumentStudio.

Adding a Remote RFmx Panel to Your Layout

Complete the following steps to view RFmx hardware measurements remotely using an InstrumentStudio panel.

Before you can view RFmx hardware measurements remotely, you must [configure your system](#).

1. Enable the remote RFmx panel feature in InstrumentStudio settings.
2. Click **Add remote host connection**.
3. Select **Remote Instrument** as the **Host type**.
4. Enter the IP address or hostname and the port number of the server you want to connect to.
5. Click **OK** to add a panel for the remote device to your layout.
6. Continue setting up your layout as needed.

After adding the panel to your layout, the device name will appear as follows: **Device Name-Model Number (Remote)**.



Note You must take over a device session to interact with a device in control mode. You can only view panels in debug mode when the session is running locally on the device.

Related information:

- [Configuring Your System for Remote RF Signal Analyzer Panels](#)

Managing Remote Connection Preferences

1. Go to **File » Preferences » Remote connections**.
2. Choose from the following options to manage remote connections:

Option	Description
Remove a Connection	Right-click Remove device .
Select a Default Device	Right-click a device from the available device list and select Make default device . InstrumentStudio will use this device when

Option	Description
	creating auto-layouts.

SCPI Instrument Panels

You can create instrument panels using SCPI-capable devices the same way you create instrument panels for native NI hardware. SCPI instrument panels do not include all of the capabilities present in native NI instruments. These panels are primarily intended to use as companions to third-party hardware, and can perform essential tasks like fetching data, screenshots, and SCPI configuration. Refer to the following sections for more information on adding SCPI instrument panels to your project.

Connecting to SCPI-Capable Devices using NI-VISA

Before InstrumentStudio can detect your SCPI-capable device, you must first connect the device to your system using Hardware Configuration Utility or Measurement & Automation Explorer (MAX). Refer to the ***Hardware Configuration Utility User Manual*** or ***Measurement & Automation Explorer Help*** for information on connecting VISA devices.

Adding SCPI Instrument Panels to a Project

You can add SCPI instrument panels to a project by selecting **Manual Layout** from the Home screen. Search for the device(s) you would like to include in the layout in the left panel of the Edit Layout window under **Instruments » VISA Instruments**

Additional Setup for SCPI Instrument Panels

Some SCPI instrument panels require additional set up to ensure use with InstrumentStudio.



Tip Look for devices named **Unknown Instrument** when selecting a SCPI-capable device from the Manual Layout window. This indicates that the device was successfully discovered by InstrumentStudio, but requires further set up.

Refer to the following section for more information on how to perform additional set up for SCPI-capable devices.

Configuring an SCPI-Capable Device

SCPI-capable devices are supported for use in InstrumentStudio, but most devices will require additional configuration. Complete the following steps to configure an SCPI instrument and add it to your InstrumentStudio project.

1. Add your instrument to your system using either Hardware Configuration Utility or MAX.
2. In InstrumentStudio, go to Manual layout.
3. Find your instrument and add it to a panel.
4. When attempting to create a SCPI instrument panel that requires additional set up, you will be prompted to set up the panel. Click the appropriate button to proceed. A file explorer window will open at the location of a new JSON configuration file that will be associated with the selected SCPI-capable device.
5. Open the new JSON file by navigating to %PROGRAMDATA%\National Instruments\Services\Scpi\ScriptDefinitions.



Note You can also access this file from an SCPI panel. Open the instrument header menu (⚙) and select **Open SCPI Support File Location**.

6. Read through the comments included in the JSON file to understand what each section of the template does, and how to modify them for your instrument. For example, make sure the `Channels` section matches the number of available channels on your device. If you are setting up a 2-channel instrument, you would remove the last two channels from this list.

```
// List of all channels available on the instrument.
"Channels": [
  {
    "DisplayName": "Channel 1",
    "ScpiName": "CHAN1"
  },
  {
    "DisplayName": "Channel 2",
    "ScpiName": "CHAN2"
  },
  {
    "DisplayName": "Channel 3",
    "ScpiName": "CHAN3"
  },
  {
    "DisplayName": "Channel 4",
    "ScpiName": "CHAN4"
  },
  {
    "DisplayName": "Channel 5",
    "ScpiName": "CHAN5"
  },
  {
    "DisplayName": "Channel 6",
    "ScpiName": "CHAN6"
  },
  {
    "DisplayName": "Channel 7",
    "ScpiName": "CHAN7"
  },
  {
    "DisplayName": "Channel 8",
    "ScpiName": "CHAN8"
  },
  {
    "DisplayName": "Channel 9",
    "ScpiName": "CHAN9"
  },
  {
    "DisplayName": "Channel 10",
    "ScpiName": "CHAN10"
  },
  {
    "DisplayName": "Channel 11",
    "ScpiName": "CHAN11"
  },
  {
    "DisplayName": "Channel 12",
    "ScpiName": "CHAN12"
  },
  {
    "DisplayName": "Channel 13",
    "ScpiName": "CHAN13"
  },
  {
    "DisplayName": "Channel 14",
    "ScpiName": "CHAN14"
  },
  {
    "DisplayName": "Channel 15",
    "ScpiName": "CHAN15"
  },
  {
    "DisplayName": "Channel 16",
    "ScpiName": "CHAN16"
  },
  {
    "DisplayName": "Channel 17",
    "ScpiName": "CHAN17"
  },
  {
    "DisplayName": "Channel 18",
    "ScpiName": "CHAN18"
  },
  {
    "DisplayName": "Channel 19",
    "ScpiName": "CHAN19"
  },
  {
    "DisplayName": "Channel 20",
    "ScpiName": "CHAN20"
  },
  {
    "DisplayName": "Channel 21",
    "ScpiName": "CHAN21"
  },
  {
    "DisplayName": "Channel 22",
    "ScpiName": "CHAN22"
  },
  {
    "DisplayName": "Channel 23",
    "ScpiName": "CHAN23"
  },
  {
    "DisplayName": "Channel 24",
    "ScpiName": "CHAN24"
  },
  {
    "DisplayName": "Channel 25",
    "ScpiName": "CHAN25"
  },
  {
    "DisplayName": "Channel 26",
    "ScpiName": "CHAN26"
  },
  {
    "DisplayName": "Channel 27",
    "ScpiName": "CHAN27"
  },
  {
    "DisplayName": "Channel 28",
    "ScpiName": "CHAN28"
  },
  {
    "DisplayName": "Channel 29",
    "ScpiName": "CHAN29"
  },
  {
    "DisplayName": "Channel 30",
    "ScpiName": "CHAN30"
  },
  {
    "DisplayName": "Channel 31",
    "ScpiName": "CHAN31"
  },
  {
    "DisplayName": "Channel 32",
    "ScpiName": "CHAN32"
  },
  {
    "DisplayName": "Channel 33",
    "ScpiName": "CHAN33"
  },
  {
    "DisplayName": "Channel 34",
    "ScpiName": "CHAN34"
  },
  {
    "DisplayName": "Channel 35",
    "ScpiName": "CHAN35"
  },
  {
    "DisplayName": "Channel 36",
    "ScpiName": "CHAN36"
  },
  {
    "DisplayName": "Channel 37",
    "ScpiName": "CHAN37"
  },
  {
    "DisplayName": "Channel 38",
    "ScpiName": "CHAN38"
  },
  {
    "DisplayName": "Channel 39",
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  },
  {
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    "ScpiName": "CHAN40"
  },
  {
    "DisplayName": "Channel 41",
    "ScpiName": "CHAN41"
  },
  {
    "DisplayName": "Channel 42",
    "ScpiName": "CHAN42"
  },
  {
    "DisplayName": "Channel 43",
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  {
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    "ScpiName": "CHAN44"
  },
  {
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    "ScpiName": "CHAN45"
  },
  {
    "DisplayName": "Channel 46",
    "ScpiName": "CHAN46"
  },
  {
    "DisplayName": "Channel 47",
    "ScpiName": "CHAN47"
  },
  {
    "DisplayName": "Channel 48",
    "ScpiName": "CHAN48"
  },
  {
    "DisplayName": "Channel 49",
    "ScpiName": "CHAN49"
  },
  {
    "DisplayName": "Channel 50",
    "ScpiName": "CHAN50"
  },
  {
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    "ScpiName": "CHAN51"
  },
  {
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    "ScpiName": "CHAN52"
  },
  {
    "DisplayName": "Channel 53",
    "ScpiName": "CHAN53"
  },
  {
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    "ScpiName": "CHAN54"
  },
  {
    "DisplayName": "Channel 55",
    "ScpiName": "CHAN55"
  },
  {
    "DisplayName": "Channel 56",
    "ScpiName": "CHAN56"
  },
  {
    "DisplayName": "Channel 57",
    "ScpiName": "CHAN57"
  },
  {
    "DisplayName": "Channel 58",
    "ScpiName": "CHAN58"
  },
  {
    "DisplayName": "Channel 59",
    "ScpiName": "CHAN59"
  },
  {
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    "ScpiName": "CHAN60"
  },
  {
    "DisplayName": "Channel 61",
    "ScpiName": "CHAN61"
  },
  {
    "DisplayName": "Channel 62",
    "ScpiName": "CHAN62"
  },
  {
    "DisplayName": "Channel 63",
    "ScpiName": "CHAN63"
  },
  {
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    "ScpiName": "CHAN64"
  },
  {
    "DisplayName": "Channel 65",
    "ScpiName": "CHAN65"
  },
  {
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    "ScpiName": "CHAN66"
  },
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  },
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  },
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    "ScpiName": "CHAN69"
  },
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    "ScpiName": "CHAN70"
  },
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    "ScpiName": "CHAN71"
  },
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    "ScpiName": "CHAN72"
  },
  {
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    "ScpiName": "CHAN73"
  },
  {
    "DisplayName": "Channel 74",
    "ScpiName": "CHAN74"
  },
  {
    "DisplayName": "Channel 75",
    "ScpiName": "CHAN75"
  },
  {
    "DisplayName": "Channel 76",
    "ScpiName": "CHAN76"
  },
  {
    "DisplayName": "Channel 77",
    "ScpiName": "CHAN77"
  },
  {
    "DisplayName": "Channel 78",
    "ScpiName": "CHAN78"
  },
  {
    "DisplayName": "Channel 79",
    "ScpiName": "CHAN79"
  },
  {
    "DisplayName": "Channel 80",
    "ScpiName": "CHAN80"
  },
  {
    "DisplayName": "Channel 81",
    "ScpiName": "CHAN81"
  },
  {
    "DisplayName": "Channel 82",
    "ScpiName": "CHAN82"
  },
  {
    "DisplayName": "Channel 83",
    "ScpiName": "CHAN83"
  },
  {
    "DisplayName": "Channel 84",
    "ScpiName": "CHAN84"
  },
  {
    "DisplayName": "Channel 85",
    "ScpiName": "CHAN85"
  },
  {
    "DisplayName": "Channel 86",
    "ScpiName": "CHAN86"
  },
  {
    "DisplayName": "Channel 87",
    "ScpiName": "CHAN87"
  },
  {
    "DisplayName": "Channel 88",
    "ScpiName": "CHAN88"
  },
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    "ScpiName": "CHAN89"
  },
  {
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    "ScpiName": "CHAN90"
  },
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    "ScpiName": "CHAN91"
  },
  {
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    "ScpiName": "CHAN92"
  },
  {
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    "ScpiName": "CHAN93"
  },
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    "ScpiName": "CHAN94"
  },
  {
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    "ScpiName": "CHAN95"
  },
  {
    "DisplayName": "Channel 96",
    "ScpiName": "CHAN96"
  },
  {
    "DisplayName": "Channel 97",
    "ScpiName": "CHAN97"
  },
  {
    "DisplayName": "Channel 98",
    "ScpiName": "CHAN98"
  },
  {
    "DisplayName": "Channel 99",
    "ScpiName": "CHAN99"
  },
  {
    "DisplayName": "Channel 100",
    "ScpiName": "CHAN100"
  }
]
```

```
{
  "DisplayName": "Channel 3",
  "ScpiName": "CHAN4"
},
{
  "DisplayName": "Channel 4",
  "ScpiName": "CHAN4"
},
],
```

7. Save and close the file.



Notice Do not change the name of the file, or move it from the folder it was created in.

8. Open the instrument header menu (⚙️) and select **Refresh panel**.

Refer to ***Additional Information About SCPI Instruments*** for more information on configuring SCPI instruments. Refer to ***Using SCPI Instruments*** for information on fetching data and configuration settings from SCPI instruments.

Additional Information About SCPI Instruments

The following sections provide additional details about SCPI instrument support in InstrumentStudio.

Supported SCPI Instrument Types

InstrumentStudio supports the use of SCPI-capable oscilloscopes, SMUs, and DMMs. Generic support is available for other device types.

SCPI-Capable Device Vendors

NI has tested SCPI-capable instruments from the following vendors:

- Agilent
- Keysight
- Tektronix
- Fluke
- Keithley

Configuration files are installed with InstrumentStudio for each of the vendors listed above.



Note Although exhaustive testing of third-party SCPI-capable devices is not possible, the included configuration files typically work for all devices from a vendor.

SCPI-Capable Devices from Other Vendors

A generic configuration file is installed with InstrumentStudio to support SCPI-capable devices from other vendors. When you add one of these devices to a panel, a new JSON configuration file is generated. This file may require modification. Refer to the notes in the JSON template files for specific instructions.



Note NI cannot guarantee all SCPI-capable devices for other vendors will work as expected in InstrumentStudio. Refer to the documentation for your device for more details on its SCPI command set.

Examples and Templates

A collection of configuration file examples and templates is installed with InstrumentStudio. Go to `%PROGRAMFILES%\National Instruments\Shared\Services\Scpi\ScriptDefinitions\Examples` to view these examples and templates. The examples provide additional details about different script types and associated device commands to help you configure your SCPI instrument.



Note Other product and company names listed are trademarks or trade names of their respective companies.

Using SCPI Instruments

The following sections contain instructions for performing common tasks using SCPI instruments.

Fetching Data From a SCPI Instrument

Complete the following steps to fetch data from a SCPI instrument.

InstrumentStudio fetches data from the last time a SCPI instrument performed a measurement. Fetching SCPI instrument data does not trigger acquisition.

1. Select the data you want to capture using the checkboxes in the instrument panel.
 - **Channels**— select specific channels to fetch data from. This option sends a `SetChannel` SCPI command to the device.



Important You must select at least one channel to fetch data.

- **Include screen image**— fetches an image of your SCPI instrument screen. The fetched image will either be a `.png` or `.bmp`, depending on the device.
2. Click **Fetch Data** to fetch the data from the selected sources.




Note You can also capture this data using **Capture Data** and **Capture Screenshot**.

To fetch new data, trigger data collection on your SCPI instrument and repeat this process.


SCPI Instrument Configuration Management

When you make changes to your device, such as turning a setting knob or pressing a button, the configuration settings for the device change and are stored in the device. If you have a preferred configuration to perform a specific task, you can fetch and store these settings in your SCPI instrument panel for later use. The following sections describe how to manage configuration settings within your project.

Fetch Existing Configuration Settings


To fetch configuration settings from a device, click  to open the instrument configuration utility. Click the **Fetch Configuration** tab, then click **Fetch** to fetch the device configuration settings. The settings will appear in the configuration utility window. To store the fetched configuration data to the selected panel, save your InstrumentStudio project.

Applying Configuration Setting

To apply device settings stored in a SCPI panel, open the instrument configuration utility () , click the Fetch Configuration tab, and click **Apply**.

Sending Commands to a SCPI Device

Complete the following steps to send SCPI commands to your SCPI-capable devices using a SCPI instrument panel.

1. Click  to open the instrument configuration utility.
2. Click the Send Command tab.
3. Click **Send Command** to open the command editor.
4. Enter the command you want to send to your SCPI-capable device in the textbox.



Note Refer to your device user manual for more information on supported SCPI commands.

5. Click **Send** to send the command to your device.

Digital Multimeters

Refer to the following sections for information about setting up a digital multimeter instrument in InstrumentStudio.

Auto Range Modes

When specifying a range for a voltage or current measurement, you can select **Auto** or **Auto once** to measure a signal when you do not know which range to select. The digital multimeter (DMM) takes a series of measurements and adjusts the range until the measurement falls within the smallest range appropriate for that measurement.

- **Auto**—Takes a reading before each measurement to select the smallest appropriate range.
- **Auto once**—The first point measured determines the range for the rest of the measurements.



Note For model-specific considerations when using auto range, refer to NI-DMM documentation or the user manual for your NI-DMM device.

Related information:

- [NI Digital Multimeters](#)

Performing Cable Compensation

Typically, you connect the digital multimeter (DMM) to a device under test with switches, fixtures, or cables. These switches and fixtures can introduce undesired errors into the measurement. Open and short cable compensation minimizes these measurement errors when taking capacitance or inductance measurements.

Compensation consists of measuring the error and applying the measured error to the actual measurement to correct and minimize the errors introduced by the test system. The compensation values must be renewed before taking a measurement at a specified function and range. Any change in range or function defaults the compensation type to none, and you must perform compensation again for accurate

measurements.

Performing Open Compensation for Capacitance and Inductance Measurements

1. Disconnect the device under test (DUT) from the DMM at the connection point on the DUT. Leave the cable connected to the DMM.
2. Configure the DMM for capacitance or inductance at the desired range.
3. Open the settings (...) for the DMM channel.
4. Click **Renew** under the Open cable compensation section of the settings window.



Note These settings are not available for simulated DMM devices.

5. Click **Continue** in the Open Cable Compensation dialog box.



Note Check the device panel to make sure compensation has been applied (✓).

Performing Short Compensation for Capacitance and Inductance Measurements

1. Disconnect the DUT from the DMM at the connection point on the DUT. Leave the cable connected to the DMM.
2. Configure the DMM for capacitance or inductance at the desired range.
3. Set up a short condition using a low-impedance connection between the HI and LO terminals of the DMM. Cables and switches with low capacitance and low path resistance are recommended.
4. Open the settings (...) for the DMM channel.
5. Click **Renew** under the Short cable compensation section of the settings window.



Note These settings are not available for simulated DMM devices.

6. Click **Continue** in the Short Cable Compensation dialog box.



Note Check the device panel to make sure compensation has been applied (✓).

LCR Devices

Refer to the following sections for information about setting up an LCR instrument in InstrumentStudio.

Calibrating an LCR Device

Self-calibrate an LCR device to ensure accurate measurements.

The accuracy of a device will naturally drift over time. Self-calibration ensures more accurate measurements by compensating for board level temperature variations and device degradation, as well as ensuring that the device operates within ranges defined in your test specifications.

1. In the LCR device instrument pane, open the instrument header menu (⚙️).
2. Click **Device Slot » Calibration**.
3. For InstrumentStudio 2025 Q2 and earlier, click **Self-calibrate in MAX** to proceed to self-calibration in Measurement & Automation Explorer (MAX). Later versions of InstrumentStudio perform self-calibration without MAX.

See [When to Calibrate an LCR Device](#) for information on how often to calibrate your LCR device.

- [Performing Compensation on an LCR Device](#)

When to Calibrate an LCR Device

Performing regular LCR device calibration ensures better accuracy in your test measurements.

Performing new LCR device self-calibration is recommended if any of the following occur.

- You are installing the module in a chassis for the first time.
- You install, uninstall, or move another module in the same chassis as your LCR device.
- The ambient temperature in your test environment has changed significantly.
- The onboard temperature of the LCR device has drifted significantly (± 5 °C) since

- the last self-calibration.
- 24 hours have elapsed since the previous self-calibration.

Performing Compensation on an LCR Device

Typically, you connect an LCR device to a device under test with switches, fixtures, or cables. These devices introduce undesired errors into the measurement. Prevent measurement errors from switches, fixtures, or cables by applying compensation before taking measurements.

To apply compensation to your LCR device, perform the following steps:



Note For detailed driver documentation on performing LCR device compensation, refer to [Compensation of LCR Measurements with NI-DCPower](#).

1. [Calibrate](#) the LCR device.
2. Determine the type of cable compensation you want to perform. Click the option link for detailed instructions on performing the selected compensation.

Option	Recommended When
Standard cable compensation	You use a standard NI cable that is represented with a Cable Length profile in the Instrument Settings dialog (...) and a simple test setup. That is, the test setup excludes complex circuitry, such as switches that might affect LCR measurements.
Custom cable compensation	You use non-NI cabling and a complex test setup. That is, the test setup includes complex circuitry, such as switches that might affect LCR measurements.




Note NI recommends applying cable compensation for low-level LCR measurements where the effects of cabling might be significant relative to the quantity you are measuring.



Note NI recommends first applying short LCR compensation when using custom non-NI cabling to ensure accurate measurements.

- To determine the type of LCR compensation you want to perform, use the following criteria. Click the option link for detailed instructions on performing the selected compensation.

Option	Recommended When
Open LCR compensation	Stray admittance in your test setup influences LCR measurements. <div>  Note Such stray admittance is present in most test setups. </div>
Short LCR compensation	The impedance of your DUT is low ($<100\ \Omega$). The residual impedance of cabling and fixtures might be a significant percentage of your DUT impedance.
Load LCR compensation	The reference load value is similar to your DUT. Your test setup also includes complex circuitry, such as switches that might affect LCR measurements.



Note Open and short LCR compensations are prerequisites to performing load LCR compensation.

NI recommends performing cable and LCR device compensation after making changes to your test system setup or performing new LCR device calibration. Refer to [When to Generate New Data for Custom Cable Compensation or LCR Compensation](#) for more information on when to perform new compensations.

Applying Standard Cable Compensation

- Click **Instrument Settings** (...) in your LCR device instrument panel.
- Select your cable length from the **Cable type** drop-down.

Performing Custom Cable Compensation

Disconnect the device under test (DUT) from the LCR device at the connection point on the DUT. Leave the custom cables connected to the LCR device.



Note The connection point may be a switch, fixture, or any other circuit used to connect LCR device cabling to the DUT. When performing custom cable compensation, only the custom cables should be connected to the LCR device.

1. Click **Custom Compensation** (\rightleftarrows) in the instrument panel.
2. Click **Renew**.
3. Click **Compensate**.
4. Click **OK**.

Verify that your device is configured for custom cables by opening **Instrument Settings** (...) and selecting "Custom " from the **Cable type** dropdown.

Verify compensation is applied. Click **Custom Compensation** (\rightleftarrows) and check that **Apply compensation** is enabled.



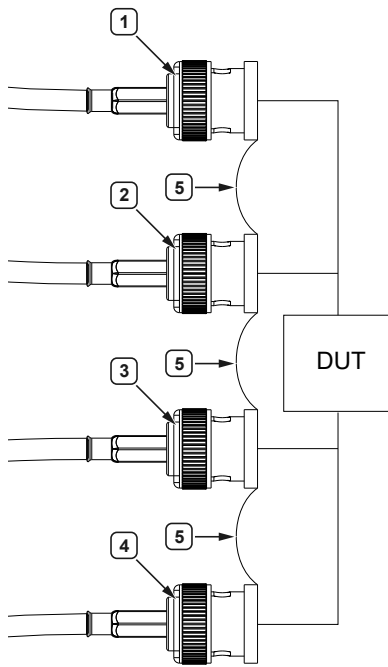
Note For detailed driver documentation on performing LCR device compensation, refer to [Compensation of LCR Measurements with NI-DCPower](#).

Performing LCR Load Compensation

Connect a reference load to the fixture that will contain your DUT.

Figure 3. Load Configuration Diagram.

Refer to the diagram below when setting up a load configuration for LCR load compensation



1. HI CUR
2. HI POT
3. LO POT
4. LO CUR
5. Connection between outer conductors

1. Click **Load Compensation** (⚙️) in the instrument panel to open the compensation dialog.
2. Click **Renew**.
3. **Optional:** Enter spots to compensate for.
4. Click **Compensate**.
5. Click **OK**.

To verify compensation is applied, click **Load Compensation** (⚙️) and check that **Apply compensation** is enabled.



Note For detailed driver documentation on performing LCR device compensation, refer to [Compensation of LCR Measurements with NI-DCPower](#).

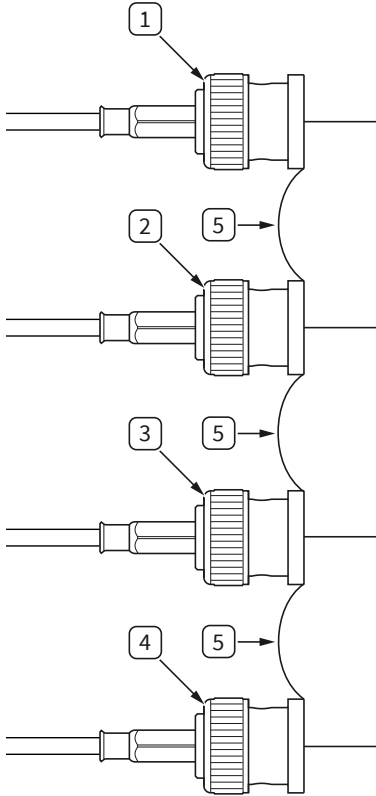
Performing Open LCR Compensation

Disconnect the device under test (DUT) from the LCR instrument at the connection


point on the DUT. Leave the cabling connected to the LCR device, and any other test system components such as switches and DUT fixtures.


Figure 4. Open Configuration Diagram.

Refer to the diagram below when setting up an open configuration for LCR open compensation



1. HI CUR
2. HI POT
3. LO POT
4. LO CUR
5. Connection between outer conductors

1. Click **Open Compensation** () in the instrument panel to open the compensation dialog.
2. Click **Renew**.
3. **Optional:** Enter additional frequencies to compensate for.
4. Click **Compensate**.
5. Click **OK**.

To verify compensation is applied, click **Open Compensation** () and check that **Apply compensation** is enabled.



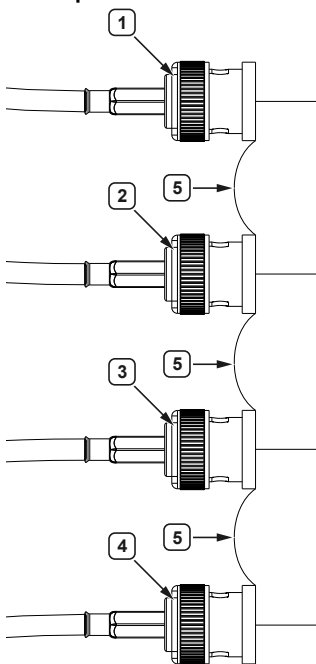
Note For detailed driver documentation on performing LCR device compensation, refer to [Compensation of LCR Measurements with NI-DCPower](#).

Performing Short LCR Compensation

Disconnect the device under test (DUT) from the LCR device at the connection point on the DUT. Leave cabling, switches, and DUT fixtures connected to the LCR device.

Figure 5. Short Configuration Diagram.

Refer to the diagram below when setting up a short configuration LCR short compensation



1. HI CUR
2. HI POT
3. LO POT
4. LO CUR
5. Connection between outer conductors

1. Click **Short Compensation** (⚙️) in the instrument panel to open the compensation dialog.
2. Click **Renew**.
3. **Optional:** Enter additional frequencies to compensate for.
4. Click **Compensate**.



Note You must perform short LCR compensation when using custom non-NI cabling. Complete [custom cable compensation](#) before performing short LCR compensation.

5. Click **OK**.

To verify compensation is applied, click **Short Compensation** (🔍) and check that **Apply compensation** is enabled.



Note For detailed driver documentation on performing LCR device compensation, refer to [Compensation of LCR Measurements with NI-DCPower](#).

When to Generate New Data for Custom Cable Compensation or LCR Compensation

Performing new custom cable and LCR device compensation ensures better accuracy in test measurements after making changes to your test system setup.

Generate new custom cable compensation data or LCR compensation data if any of the following occur.

- You perform a new external calibration
- You perform a new self-calibration
- You add complex circuit elements, such as a switch, between the end of the cable and the fixture containing your DUT
- You change the length of the cabling in your test setup
- You change the physical orientation of the cabling in your test setup
- You begin testing a DUT that is different (on the basis of part number) from the DUT for which you originally generated compensation data;



Note For load LCR compensation, choose a new reference load appropriate for the new DUT.

Oscilloscopes

Refer to the following sections for information about setting up an oscilloscope

instrument in InstrumentStudio.

Oscilloscope Setup Actions

You can configure the setup of an oscilloscope using two options: Auto setup and Default setup.

- **Default setup**—Returns the device to the default configuration.
- **Auto setup**—Enables all channels and automatically configures device settings.

Settings Changed by Auto Setup

Setting an oscilloscope to Auto setup changes the following settings:

General Settings	Value
Acquisition Mode	Normal
Reference Clock	Internal

Vertical Settings	Value
Vertical Coupling	Unchanged by Auto Setup.
Vertical Bandwidth	Full
Vertical Range	Changed by Auto Setup. ¹ [1]
Vertical Offset	0 V
Probe Attenuation	Unchanged by Auto Setup.
Input Impedance	Unchanged by Auto Setup.

Horizontal Settings	Value
Sample Rate	Changed by Auto Setup. ¹ [1]
Min Record Length	Changed by Auto Setup. ¹ [1]
Enforce Realtime	True
Number of Records	1

1. Auto Setup adjusts this setting to different values depending on the signal.

Triggering Settings	Value
Trigger Type	Edge if signal present, otherwise immediate.
Trigger Channel	Lowest numbered channel with a signal present.
Trigger Slope	Positive
Trigger Coupling	DC
Reference Position	50%
Trigger Level	50% of signal on trigger channel.
Trigger Delay	0
Trigger Holdoff	0
Trigger Output	None

Setting Sample Rate and Record Length Manually

By default, InstrumentStudio optimizes the record length or the sample rate of an oscilloscope when taking measurements.

Configuring Record Length

You can configure the record length by setting **Data Display** to one of the following options:

- **Live**—InstrumentStudio sets the maximum record length to 1 million samples.
- **On Demand**—InstrumentStudio sets the maximum record length to 10 million samples.

Manual Override Mode

To configure larger records, use Manual Override mode. Manual Override mode allows for the configuration of both the sample rate and the record length of an oscilloscope.



Note NI recommends that you only enable Manual Override mode for test parameters that require specific sample rate and record length values. Otherwise, to get the best interactive experience with an oscilloscope, do not enable this setting.

Do the following steps to enable **Manual Override** mode:

1. Click **Instrument Settings** (...) in the device instrument panel of the oscilloscope.
2. Click the **Manual Override** mode toggle.
The toggle should be in the **On** position after clicking.
3. Enter the desired values for **Sample Rate** and **Record Length**.



Note if the sample rate or the record length are configured improperly, enabling **Manual Override** mode might lead to unexpected graph behavior. For example, if your device does not have enough onboard memory to accommodate measurement settings, your graphs might not render properly. You might also get an error message in InstrumentStudio. Other settings might also cause data to be unreadable or take longer than expected to appear. Take, for example, entering a **Sample rate** of 1 kS/s with a **Record length** of 3.5 MS. In this case, it takes around an hour for the measurement data to appear in your oscilloscope panel in InstrumentStudio.

Acquisition Status

You can determine the current state of an acquisition by looking at the acquisition status icon, located in the Horizontal & Acq. header of an oscilloscope panel.

- **Triggered**—The device met the trigger condition and performed an acquisition based on the specified trigger settings.
- **Auto**—After a certain amount of time has passed without a trigger firing, the device automatically triggers an acquisition. The Auto status displays briefly when this occurs.



Note The trigger mode must be set to **Auto** to enable automatic triggering.

- **Waiting**—The device is waiting to take an acquisition until the trigger condition has been met.
- **Stopped**—The instrument is not running.

Interpolation Method

You can set the interpolation method of an oscilloscope acquisition to one of the following settings from the Instrument Settings window:

- **No interpolation**—The oscilloscope does not interpolate data.
- **Auto**—The oscilloscope interpolates data when the visible time per division is too small for acquisitions performed at the maximum sample rate. If you set the sample rate of the oscilloscope to **Manual**, the oscilloscope treats the sample rate you enter as the maximum sample rate. The Auto interpolation method takes headroom into account when determining whether or not to perform interpolation; if there is low headroom between the oscilloscope's bandwidth and its sample rate, the oscilloscope does not interpolate the data.
- **On**—The oscilloscope interpolates data as often as possible without taking headroom into account. If you set the interpolation method to On, the oscilloscope will interpolate data in all cases except for the following:
 - The oscilloscope's sampling method is set to Random Interleaved Sampling (RIS).
 - The acquisition uses the peak detect sample mode.
 - The waveform has enough data and does not need interpolation.

Sampling Methods

Depending on the device, you can select different sampling methods from the Instrument Settings window of an oscilloscope:

- **Real time**—Gathers all the samples for a waveform in one acquisition with one trigger event.
- **RIS**—Random Interleaved Sampling (RIS) achieves a higher synthetic sample rate by combining several triggered waveforms.



Note RIS is not supported on all oscilloscopes. You can select RIS only with supported devices. Refer to your device's documentation to determine whether or not it supports RIS.

Sample Modes

You can select one of the following sample modes from the Instrument Settings

window when configuring an oscilloscope acquisition with InstrumentStudio:

- **Sample**—The oscilloscope measures the signal at a fixed time interval (the sample rate).
- **Peak detect**—The oscilloscope internally samples the signal at its maximum sample rate, then saves the maximum and minimum value of the input signal within the configured sample interval. Use Peak detect when you would like to acquire measurements for a longer time while still being able to detect transients.
- **Averaging**—The oscilloscope averages the waveform data of continuous acquisitions based on the averaging count. The oscilloscope performs an exponential moving average and shows the number of averages, which shows how many waveforms have been read and averaged.

Adding FFT Channels and Markers

Use FFT channels with an oscilloscope to measure amplitude and frequency of a sample. You can also fetch more detailed measurements and search for peaks using markers.

Creating FFT Channels

1. From a large oscilloscope panel, click the **FFT** button in the **Add Channels** section. A frequency graph displays.
2. Select a **Source** for the FFT channel. You can select any single existing channel.
3. Select a **Window** function for the FFT channel.
4. (Optional) Configure additional settings for the FFT channel by clicking the FFT channel's settings cog. Refer to [Searching For and Computing Peaks](#) for more information.

Creating Markers

A marker fetches the amplitude (y-location) of a particular sample at a specified frequency (x-location) of a particular sample. Complete the following steps to create a marker or markers:

1. After creating an FFT channel, select the **Markers** drop-down in the frequency graph header. Select **Markers: On** to enable markers and open the marker toolbar.
2. From the marker toolbar, select a marker to configure. By default, only Marker 0 is

enabled.



Note Enable more markers by selecting a marker from the marker toolbar and changing the marker mode from **Off** to **Normal**. You can enable up to 12 markers.

3. Select the FFT channel the selected marker should measure.
4. Enter the frequency where you want to place the marker. The amplitude of the signal at the frequency of the marker is displayed in the **Level** section of the marker toolbar.



Note You can view and edit the frequency of all enabled markers in the Markers table below the frequency graph. The Markers table also displays the markers' current level, mode, and source channel.

Searching For and Computing Peaks

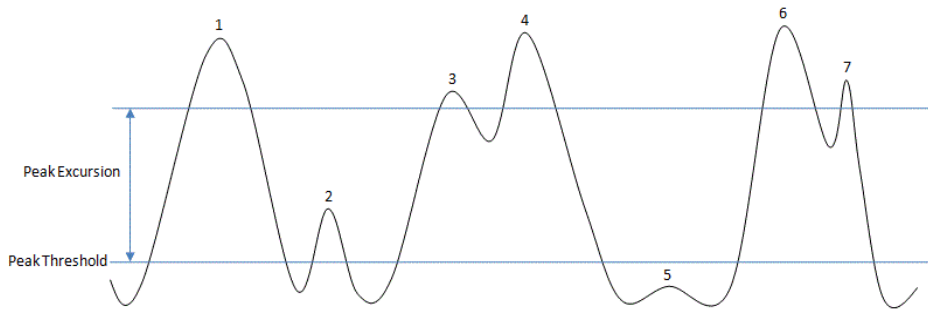
After enabling at least one FFT channel and markers, you can use the peak search functions to locate peaks. Peaks are the samples for which the amplitude rises and falls around a threshold. You can move the selected marker to the highest peak, the next highest peak, or an adjacent peak to the left or right of the marker. You can configure the peak threshold and excursion settings by selecting the cog icon next to the peak search functions.

Computing Peaks Using Peak Threshold and Excursion

The peak threshold is the minimum amplitude level a sample must rise above to be considered a peak. If peak threshold is enabled but peak excursion is not, every amplitude measurement above the threshold is considered a peak. Set the peak threshold from the peak search settings.

Peak excursion specifies the minimum amplitude variation required in a signal to be considered as a peak. Peak excursion is always specified with respect to a threshold value. A signal must rise and fall above the threshold level by at least the peak excursion value to be considered as an eligible peak.

The following figure shows how to identify a valid peak that meets excursion criteria:



Peak 1 rises and falls by at least the peak excursion value above the threshold. Hence, it follows the excursion criteria.

Peak 2 is above the threshold level, but it does not rise and fall by the excursion value above the threshold level. Hence, it does not satisfy excursion criteria.

Peak 3 rises above the threshold value by at least the excursion value, but it does not completely fall by the excursion value. The signal rises and crosses the Peak 3 amplitude level. Hence, it is not an eligible peak.

Peak 4 rises and falls by at least the peak excursion value above the threshold. Although during the rise it slightly falls (Peak 3) the net rise from the threshold level exceeds the excursion value. Hence, it is considered an eligible peak.

Peak 5 is below the threshold level. Hence, it is not detected as a peak.

Peak 6 rises by at least the peak excursion value above the threshold. During the fall, the signal slightly rises (as Peak 7), but it does not rise above peak 6 amplitude level before falling again. The total fall, which starts at the peak 6 amplitude level, is more than the excursion value. Hence, it is an eligible peak.

Peak 7 falls by the excursion value, but it does not rise by the excursion value. Hence, it does not satisfy excursion criteria.

FFT Averaging Modes

You can perform averaged measurements on an FFT channel to improve measurement accuracy or to help compensate for a low signal-to-noise ratio.

- **Disabled**—Disables FFT averaging.
- **RMS**—Root mean square. RMS averaging averages the energy (or power) of the signal, so it reduces signal fluctuations, but not the noise floor.
- **Peakhold**—Performs a peak hold averaging measurement at each individual frequency line and retains the RMS peak levels of the averaged quantities from one FFT record to the next. Peak-hold averaging is the most useful when configuring a measurement system or when applying limit or upper limit testing to a frequency spectrum.

Measuring Spectral Density

A power spectral density is the measure of a signal's power content versus frequency. You can view the power spectral density of a signal while analysing data in the frequency domain; this is helpful for determining which frequency ranges have strong or weak variations in power.

Complete the following steps to measure spectral density in InstrumentStudio:

1. Add an oscilloscope to the large panel.
2. [Create an FFT channel](#) by selecting the **FFT** button in the **Add Channels** section of the large panel.
A frequency chart opens underneath the large panel time chart.
3. Configure the FFT Axis settings:
 - a. In the header of the frequency chart, select the Chart Options button.
 - b. In the Y-axis section, change Units to V/\sqrt{Hz} or **dBm/Hz**.
 - c. In the X-axis section, set Scaling to **Logarithmic**.
4. Run the panel if it is not already running.
InstrumentStudio plots power spectral density data on the Frequency chart.

For better frequency resolution, you can configure averaging through the FFT channel settings, or you can modify the RBW through the axis settings in Chart Options.

Measurement Types

The following measurement types are available when creating oscilloscope channels with InstrumentStudio.

Amplitude	Mid Ref Level	Mean	Negative Duty Cycle
Peak-to-Peak	Low Ref Level	Median	Positive Pulse Width
High	Positive Undershoot	Cycle RMS	Negative Pulse Width
Low	Negative Undershoot	Cycle Mean	Rise Time
Maximum	Positive Overshoot	Period	Fall Time
Minimum	Negative Overshoot	Frequency	Rise Rate
High Ref Level	RMS	Positive Duty Cycle	Fall Rate
Delta Time	Setup Time	Hold Time	Crosspoint Level
Crosspoint Time	FFT Frequency	FFT Amplitude	

Related tasks:

- [Customizing Oscilloscope Measurements](#)

Amplitude



The [High](#) measurement minus the [Low](#) measurement.

Peak-to-Peak



The [Maximum](#) measurement minus the [Minimum](#) measurement.

High



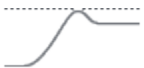
The High measurement is calculated using the selected [High-Low method](#). If you select the Histogram High-Low method, the High measurement is calculated using the most common value found in the upper 40% of the waveform. If you select the Peak High-Low method, the High measurement is calculated using the waveform's [Maximum](#) measurement value.

Low



The Low measurement is calculated using the selected [High-Low method](#). If you select the Histogram High-Low method, the Low measurement is calculated using the most common value found in the lower 40% of the waveform. If you select the Peak High-Low method, the Low measurement is calculated using the waveform's [Minimum](#) measurement value.

Maximum



The maximum value found in the waveform.

Minimum



The minimum value found in the waveform.

High Ref Level



The level of the signal at the high reference level. If you set the reference level unit to Percentage, the High Ref Level measurement is calculated with the selected High-Low method. If you set the reference level unit to Absolute, the value that you set as the High reference level is used for the measurement.

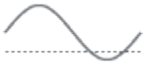
Mid Ref Level



The level of the signal at the mid reference level. If you set the reference level unit to Percentage, the Mid Ref Level measurement is calculated with the selected High-Low method. If you set the reference level unit to Absolute, the value that you set as the Mid

reference level is used for the measurement.

Low Ref Level



The level of the signal at the low reference level. If you set the reference level unit to Percentage, the Low Ref Level measurement is calculated with the selected High-Low method. If you set the reference level unit to Absolute, the value that you set as the Low reference level is used for the measurement.

Positive Undershoot



Negative Undershoot



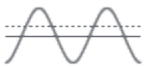
Positive Overshoot



Negative Overshoot



RMS



The true root mean square voltage over the entire waveform. This measurement uses the following formula:

$$RMS = \sqrt{\left(\frac{\sum(\text{square}(\text{waveform}[i]))}{\text{number of points}} \right)}$$

Mean



The mean over the entire waveform.

Median



The median over the entire waveform. The points in the waveform are sorted according to the following formulas:

Number of Points	Returned Value
Odd	$waveform[(n-1)/2]$
Even	$(waveform[m/2] + waveform[n/2 + 1]) / 2$

Cycle RMS

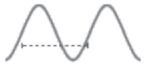


The true root mean square voltage over the first cycle of the waveform. The first cycle is determined using the values specified by the High, Mid, and Low [reference levels](#). This measurement uses the following formula:

$$\text{Cycle RMS} = \sqrt{(\text{sum}(\text{square}(\text{waveform}[i]) / \text{number of points}))}$$

where **waveform** is all the points in the first cycle of the waveform.

Cycle Mean



The voltage average over the first cycle of the waveform. The values you specify in the High, Mid, and Low [reference level fields](#) in the Settings tab of the Measurements window determine the first cycle.

Period



The time of the first two Mid [reference level](#) crossings in the same direction. A hysteresis is applied using the values specified by the High or Low reference levels.

Frequency



1.0 divided by the [Period](#) measurement, in hertz.

Positive Duty Cycle



The [Positive Pulse Width](#) divided by the [Period](#) times 100.

$$\text{Positive Duty Cycle} = (\text{Positive Pulse Width} / \text{Period}) \times 100$$

Negative Duty Cycle



The Negative Pulse Width divided by the Period times 100.

$$\text{Negative Duty Cycle} = (\text{Negative Pulse Width} / \text{Period}) \times 100$$

Positive Pulse Width



The time difference in seconds between the first two Mid reference level crossings, where the first slope is positive and the second is negative. The High or Low reference levels are used to apply a hysteresis.

Negative Pulse Width



The time difference in seconds between the first two Mid reference level crossings, where the first slope is negative and the second is positive. The High or Low reference levels are used to apply a hysteresis.

Rise Time



The time span of the first rising edge of the waveform to cross the Low reference level until it crosses the High reference level. The time span starts from the Low reference level crossing immediately preceding the High reference level crossing.

Fall Time



The time span between when the first falling edge of the waveform crosses the High reference level to when the same falling edge crosses the Low reference level.

Rise Rate



The Rise Time divided by the High reference level minus the Low reference level.

$$\text{Rise Rate} = \text{Rise Time} / (\text{High reference level} - \text{Low reference level})$$

Fall Rate



The Fall Time divided by the High reference level minus the Low reference level.

$$\text{Fall Rate} = \text{Fall Time} / (\text{High reference level} - \text{Low reference level})$$

Delta Time



The time span from when the first edge of the waveform crosses the Mid reference level until the second edge of the waveform crosses the Mid reference level. The second edge can be configured to another channel.

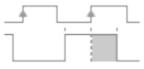
Setup Time



The time span from when the waveform crosses the Mid reference level until the configured clock channel crosses the Mid reference level. The Setup Time

measurement uses the crossing of the clock channel that is closest to the middle of the graph.

Hold Time



The time span from when the configured clock channel crosses the Mid [reference level](#) until the waveform crosses the Mid reference level. The Hold Time measurement uses the crossing of the clock channel that is closest to the middle of the graph.

Crosspoint Level



The level at which two waveforms intersect. The second waveform can be configured to another channel. The crosspoint level measurement uses the intersection closest to the middle of the graph.

Crosspoint Time



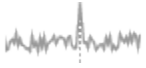
The time at which two waveforms intersect. The second waveform can be configured to another channel. The crosspoint time measurement uses the intersection closest to the middle of the graph.

FFT Amplitude



Calculates a real FFT and returns the maximum amplitude. The search ignores the DC bin of the FFT; peaks close to DC (but not in the DC bin) are detected.

FFT Frequency



Calculates a real FFT and returns the frequency that corresponds to the maximum amplitude. The search ignores the DC bin of the FFT; peaks close to DC (but not in the DC bin) are detected.

Customizing Oscilloscope Measurements

You can use reference levels and gating to customize the measurements displayed in the measurement table. To customize these settings:

1. Click **Add/Remove** in the measurement table of an oscilloscope.
2. Click the Settings tab of the Measurements window to configure oscilloscope measurements.

Gating

Use gating options to select the region of captured data used to perform measurements displayed in the measurement table.

- **Screen**—Performs measurements only on the data visible in the large panel's Time domain graph.
- **Record**—Performs measurements on the full data record.
- **Custom**—Performs measurements only on the data between set positions. Configure custom gating positions using time values relative to the triggered data capture starting point.
 - **Position 1**—Sets the first position of gated data relative to the trigger to calculate measurements.
 - **Position 2**—Sets the second position of gated data relative to the trigger to calculate measurements.

Reference Levels

Customize the oscilloscope measurements displayed on the measurement table by adjusting the reference levels and the High-Low method from the **Settings** tab of the

Measurements window.

High, Mid, and Low Reference Levels

Reference levels are range values that divide a waveform into high, middle, and low sections by intersecting the waveform at specified amplitude. Use reference levels to ascertain rise and fall times, calculate waveform cycles, and customize some oscilloscope measurement types. In InstrumentStudio, set reference levels by either absolute levels or the percentage of the waveform to acquire. The following oscilloscope measurement types are calculated using reference levels:

- [High Ref Level](#)
- [Mid Ref Level](#)
- [Low Ref Level](#)
- [Cycle RMS](#)
- [Cycle Mean](#)
- [Period](#)
- [Rise Time](#)
- [Fall Time](#)
- [Rise Rate](#)
- [Fall Rate](#)

Reference Level Unit

Use the **Reference Level Unit** settings to specify if reference levels are interpreted as percentages of the waveform or as absolute levels.

- **Percentage**—Interprets the reference levels as a percentage using the selected High-Low method.
- **Absolute**—Interprets the reference levels as absolute levels, such as volts.

High-Low Method

If you set the **Reference Level Unit** setting to **Percentage**, configure how the state levels are computed by selecting the High-Low method:

- **Auto-select**—Determines whether the histogram bins that correspond to the high and low state levels each have over 5% of the total hits. If so, the device returns those results. If not, the device uses the Peak High-Low method. The Auto-select High-Low method provides an answer for either a square wave (by ignoring the overshoot and undershoot) or a triangle wave (where the Histogram High-Low method fails).
- **Histogram**—Computes state levels using the histogram bins with the maximum

number of hits in the upper and lower regions of the waveform. The upper and lower regions of the waveform include the upper and lower 40% of the peak-to-peak range of the waveform.

- **Peak**—Searches the waveform for its maximum and minimum levels.

Network Analyzers



Refer to the following sections for information about setting up a network analyzer instrument in InstrumentStudio.



Note The RFmx VNA personality is supported for use with network analyzer instruments.

Characterizing RF Devices

Use the Network Analyzer instrument to perform measurements and characterize RF devices.

1. Create a Network Analyzer instrument by clicking  » **Network Analyzer**.
2. Click the  button to open the settings panel and configure the instrument.
3. If you have not already done so, calibrate your Network Analyzer and apply corrections before proceeding to the next step. Uncalibrated devices may generate unexpected and inaccurate results when taking measurements.
4. Connect your DUT, if it is not already connected.
5. Run the measurement by clicking **RUN** to measure continuously or **SINGLE** to capture a single measurement.

Applying Corrections to Network Analyzers

Applying adjustments generated during the calibration process is critical to ensuring accurate measurements.

Make sure you have already performed calibration on your device and saved a calset file before proceeding.

1. Click **Load Calset from File**.
2. Select the calibration data file that corresponds to your current configuration and

click **Open**.

3. Make sure the **Correction Enabled** box is checked.

Adjustments will now be automatically applied when using this instrument.

Related information:

- [PXIe-5842 Self-Calibration](#)

RF Signal Analyzers

Refer to the following sections for information about setting up an RF signal analyzer instrument in InstrumentStudio.

Analyzing RF Signals with an RF Signal Analyzer

Create an RF signal analyzer panel to monitor and configure RF signal analyzer settings in InstrumentStudio.

1. Create an RF Signal Analyzer panel.
The default Spectrum Analyzer view will appear in the instrument panel.
2. Select the personality you want to use to measure from the RFmx Personalities dropdown.



Note If the desired personality does not appear in the dropdown, make sure the [personality is supported](#) in InstrumentStudio, and make sure the driver for that personality is installed.

The instrument panel and highlighted settings in the instrument configuration panel will change based on selected personality.

3. Select the desired measurements from the settings panel using the **Add/Remove** button.
4. Configure center frequency, reference level, and any other important values for the signal being analyzed in the settings panel.
5. View the results and traces in the measurement pane.

Supported RFmx Personalities

The following list contains the RFmx personalities supported in InstrumentStudio for use with RF Signal Analyzer panels.

- Spectrum Analyzer
- GSM
- LTE / LTE-Advanced
- NR
- TD-SCDMA
- WCDMA
- Bluetooth
- WLAN
- Pulse

De-Embedding RFSA Devices

De-embedding refers to the process of removing the effects of test fixture cabling and components. Applying de-embedding to an RF signal ensures more accurate results when reading data from your RF device. Once applied, the de-embedded signal you see at the device port matches the requested signal settings.

De-embedding

To access de-embedding properties, open the RF device **Instrument Settings** dialog box (...), click the **RF** tab, and scroll down to De-embedding. The following are options you can configure to apply de-embedding your RF device:

- **Type**—Specifies the type of de-embedding you want to use.
 - None—De-embedding is disabled.
 - Scalar—De-embeds the signal using the gain term.
 - Vector—De-embeds the signal using the gain term and reflection term.
- **Status**—Displays whether an S2P table is loaded into the device session.
- **Load table from S2P file**—Loads an S2P file into the device session to use for de-embedding.



Note

- S2P tables are used to incorporate S-parameters into signal de-embedding. S-parameters characterize the effects of a linear network on a signal when it passes from one port to another. Refer to the installed RF driver documentation for more information.
- You must configure de-embedding for each port when using multi-port modules.

Performing RF Signal Analyzer Self-Calibration

Self-calibrate an RF signal analyzer device to ensure accurate measurements.

The accuracy of a device will naturally drift over time. Self-calibration ensures more accurate measurements by compensating for board level temperature variations and device degradation, as well as ensuring that the device operates within ranges defined in your test specifications.

Performing Self-Calibration

1. In the device panel, open the instrument header menu (⚙).
2. Click **Device Slot** » **Calibration** » **Self Calibrate...** to begin self-calibration.



Note InstrumentStudio will warn you that the process may take several minutes to finish, and will lock the instrument until the process completes.

3. Click **Continue** to proceed.

Performing Self-Calibration Range

This mode of calibration completes more quickly than general self-calibration.



Note This calibration is only valid until you restart your system.

1. In the device panel, open the instrument header menu (⚙).
2. Click **Device Slot** » **Calibration** » **Self Calibrate Range....**
3. Under **Steps to omit** in the dialog box, select any steps you want InstrumentStudio to skip during the self-calibration process.

4. Under **Ranges**, enter the values for the desired ranges of self-calibration.
5. Click **Continue** to proceed, or **Cancel** to cancel the operation.

Checking Calibration History

1. In the device panel, open the instrument header menu (⚙️).
2. Click **Device Slot** » **Calibration** » **History**.

Importing Bitfile Data

Bitfiles define FPGA configurations, enabling you to customize your RF device for specific testing applications. Loading a bitfile to an InstrumentStudio RFSG or RFSA instrument will both load the specified configuration on the hardware device, as well as set the file as the default file to associate with the device model in InstrumentStudio. Complete the following steps to associate an existing bitfile with your RF instrument.



Note Your device must have a user-accessible FPGA to load custom bitfiles. Refer to the **NI-RFSA** and **NI-RFSG** API reference manuals for details on which devices support this feature.

1. In the device panel, open the instrument header menu (⚙️).
2. Click **Bitfile**.



Note A bitfile must be present in the following folder before you can complete this step:

```
User\Public\Documents\National Instruments\FPGA
Extensions Bitfiles\target name
```

3. Select the bitfile you want to use and click **OK**.
InstrumentStudio prompts you to restart the application. You must restart InstrumentStudio before changes take effect.

InstrumentStudio uses the selected bitfile as the default file for both NI-RFSG and NI-RFSA instruments for this device model.

Related information:

- [NI-RFSA API Reference Manual](#)
- [NI-RFSG API Reference Manual](#)

RF Signal Generators

Refer to the following sections for information about setting up an RF signal generator instrument in InstrumentStudio.

Generating RF Signals with an RF Signal Generator

Create an RF signal generator panel to monitor and configure RF signal generator settings in InstrumentStudio.

1. Add an RF signal generator device to your panel.
2. Select a mode of operation within the device panel.
 - **Continuous Waveform (CW)**—Configures the RF signal generator to output a continuous waveform at the specified frequency and the specified level.
 - **Arbitrary Waveform (Arb)**—Configures the RF signal generator to output a complex signal according to the waveform and the waveform settings that are specified in an external file.
 - **Script**—Configures an RF signal generator to output a sequence of multiple waveforms according to the instructions specified in the script text. For more information on scripting, see ***NI-RFSG User Manual*** at ni.com/docs.
3. Specify the type of signal to generate.
 - If you want to generate a CW signal, specify the signal settings by opening the **Instrument Settings (...)** dialog box.
 - If you want to generate an arbitrary waveform, click the **Add Waveform** button next to **Select Waveform**. Then select a waveform file. Specify the signal settings by opening the **Instrument Settings (...)** dialog box.
4. Select **Run** and set the output to On. The signal generates with the settings you specify.



Note

- The panel will already be running in CW mode, and you only need to set output to **On** to output a generated waveform. In Arb mode, you must first select a waveform, then press **Run**.
- The panel will continue running and generate the waveform continuously unless you set **Waveform repetition mode** is to Finite when configuring your signal settings. When set to Finite, the panel will output the specified number of repetitions and then stop.

Related tasks:

- [Creating a Layout](#)

Related information:

- [NI-RFSG User Manual](#)

Arbitrary Waveform Properties

Settings and values associated with waveforms generated in **Arbitrary Waveform** mode.

When changing a waveform, waveform property values update to reflect the settings for that waveform. When downloading a waveform from file, the property values are automatically populated with the values found in the file. Any changes made to the waveform properties only affect the selected waveform.

Debugging Test Programs

Waveform properties were introduced in the NI-RFSG 20.7 driver. Prior to that release, only a subset of these properties was available, and they applied globally to all waveforms. When debugging a test program that still utilizes these global properties, the global values will be shown for the selected waveform. Any subsequent edits in InstrumentStudio will only apply to the selected waveform.

The following table shows legacy property names that map to new RFSG property names:

Global Property Name	RFSG Arbitrary Waveform Property Name
IQ Rate	IQ Rate
Peak Power Adjustment	PAPR
Pre-filter Gain	Run time Scaling
Signal Bandwidth	Signal Bandwidth

Waveform Properties in Script Mode

Settings and values associated with waveforms generated in **Script** mode.

When operating in **Script** mode, the following sets of properties are present:

- The properties under the **Script** section correspond to the global properties that are used for the selected script.
- The properties under the **Waveforms** section correspond to the waveform properties and show the values for the selected waveform.

Waveform properties take precedence over the global properties.

Performing RF Signal Generator Self-Calibration

Self-calibrate an RF signal generator device to ensure accurate measurements.

The accuracy of a device will naturally drift over time. Self-calibration ensures more accurate measurements by compensating for board level temperature variations and device degradation, as well as ensuring that the device operates within ranges defined in your test specifications.

Performing Self-Calibration

1. In the device panel, open the instrument header menu (⚙️).
2. Click **Device Slot** » **Calibration** » **Self Calibrate...** to begin self-calibration.



Note InstrumentStudio will warn you that the process may take several minutes to finish, and will lock the instrument until the process completes.

3. Click **Continue** to proceed.

Performing Self-Calibration Range

This mode of calibration completes more quickly than general self-calibration.



Note This calibration is only valid until you restart your system.

1. In the device panel, open the instrument header menu (⚙️).
2. Click **Device Slot » Calibration » Self Calibrate Range....**
3. Under **Steps to omit** in the dialog box, select any steps you want InstrumentStudio to skip during the self-calibration process.
4. Under **Ranges**, enter the values for the desired ranges of self-calibration.
5. Click **Continue** to proceed, or **Cancel** to cancel the operation.

Checking Calibration History

1. In the device panel, open the instrument header menu (⚙️).
2. Click **Device Slot » Calibration » History.**

RF Signal Generator Status

An RF signal generator can be in one of the following states:

- **Generating Output**—Signal generation is running and being output on this channel. Generating can also mean the channel is waiting for a trigger.
- **Not Generating Output**—Signal generation is stopped on this channel.
- **Unknown**—Signal generation status is unknown.



Note The panel must be running and the output set to On for the RF signal generator to output the waveform. Output stops when closing an RF signal generator panel except when monitoring an external session.

De-embedding RFSG Devices

De-embedding refers to the process of removing the effects of test fixture cabling and components. Applying de-embedding to an RF signal ensures more accurate

results when reading data from your RF device. Once applied, the de-embedded signal you see at the device port matches the requested signal settings.

De-embedding

To access de-embedding properties, open the RF device **Instrument Settings** dialog box (...), click the **RF** tab, and scroll down to De-embedding. The following are options you can configure to apply de-embedding your RF device:

- **Type**—Specifies the type of de-embedding you want to use.
 - None—De-embedding is disabled.
 - Scalar—De-embeds the signal using the gain term.
 - Vector—De-embeds the signal using the gain term and reflection term.
- **Status**—Displays whether an S2P table is loaded into the device session.
- **Load table from S2P file**—Loads an S2P file into the device session to use for de-embedding.



Note

- S2P tables are used to incorporate S-parameters into signal de-embedding. S-parameters characterize the effects of a linear network on a signal when it passes from one port to another. Refer to the installed RF driver documentation for more information.
- You must configure de-embedding for each port when using multi-port modules.

SMU and VPS Devices

Refer to the following sections for information about setting up a SMU and VPS instruments in InstrumentStudio.

SMU/VPS Modes of Operation

Device Operating Modes

You can use one of the following modes for acquiring measurements using an SMU or VPS device in InstrumentStudio: Chart, Waveform, and Sweep.

Operating Mode	Sourcing Behavior	Large Panel Plotting Behavior	Pause Behavior	Potential Uses	Notes
Chart	Allows one or more channels to source a supported signal.	Appends samples to the chart as they are measured.	Channels continue to source at the last configured level when you pause measurements.	Observe signals over an infinite duration.	
Waveform	Allows one or more channels to source a supported signal.	Plots samples to the graph all at once; the length of the graph is determined by capture time.	Channels continue to source at the last configured level when you pause measurements.	Observe signals over a shorter, finite duration, similar to an oscilloscope.	Unless you press Single , InstrumentStudio automatically configures the device for a faster sample rate and runs the output continuously in a loop.
Sweep	Sweeps through configured steps for a single channel (Single-Channel Sweep) or two channels (Two-Channel Sweep).	Plots sample step results on the graph as they are measured.	Both measurement and output channels are paused when you pause measurements.	Allows you to plot the relationship between current and voltage in an I-V curve.	When you are using Two-Channel Sweep, the sweep acts as a nested loop, where the inner channel executes all the steps for each step configured in the outer channel.
Sweep (LCR Mode)	Sweeps through configured frequency or DC bias steps for a single channel (Single Channel	Plots sample step results on the graph as they are measured.	Both measurement and output channels are paused when you pause measurements.	Allows you to plot the relationship between frequency or DC bias and enabled LCR readbacks.	

Operating Mode	Sourcing Behavior	Large Panel Plotting Behavior	Pause Behavior	Potential Uses	Notes
	Sweep)				



Note **Waveform** and **Sweep** modes are not available on PXI-4110, PXIe-4112, PXIe-4113, PXI-4130, or PXI-4132 devices.



Note **Waveform** mode is only available for single-channel sessions in debug mode. **Waveform** mode is disabled when a session contains two channels.



Note **Sweep** mode is available on PXIe-4190 device when operating in LCR mode. To change to LCR mode, go to the Channel settings within the device panel, click the **Mode** drop-down, and select **LCR meter**.

Channel Operating Modes

In addition to device operating modes, you can also specify an operating mode for each channel. Some channel operating modes are only available on devices with certain capabilities.

If you change the operating mode of a channel, all panel measurements are paused. Any enabled outputs continue to generate signal at the last configured level. The new operating mode of the channel will not take effect until you run the panel.

- **Idle**—The channel is not programmed. If you change a channel to Idle from another mode, the channel continues to generate signal according to its last configuration.
- **Voltage or Current**—Sources DC voltage or DC current at a single configured level while the output is enabled.
- **Power or Resistance**—Sources a constant power or a constant resistance at a single configured level, up to a current limit, while the output is enabled. Applies to electronic loads.



Note For electronic loads, references in documentation and software to

sourcing and **output** actually refer to **sinking** and **input**, respectively. InstrumentStudio classifies an electronic load as an SMU/power supply.

- **Pulse voltage or Pulse current**—Generates a single pulse at the pulse level, then returns to the bias level.



Note InstrumentStudio currently supports single point pulsing only; InstrumentStudio 2019 does not support pulse sequencing.

- **Voltage sequence or Current sequence**—Allows you to configure a level and a duration for each step in a list. You can configure the list of steps on the device panel, or import steps from a .CSV file. For more information on creating voltage sequences or current sequences, refer to [Configuring Sequences](#).



Note

- If step sequence is imported from a .CSV file, the .CSV file must have two columns: the first for the level, and the second for the duration.
- Voltage sequence and current sequence modes are not available on the PXI-4110, PXIe-4112, PXIe-4113, PXI-4130, or PXI-4132 devices.

SMU Measurement Autorange

When the range for a signal is unknown, using measurement autorange enables the signal range to be automatically determined.

When a measured signal exceeds the specified range in InstrumentStudio, InstrumentStudio will not be able to accurately measure that signal, and will warn you that the measurement is over range. When you [enable measurement autorange](#), InstrumentStudio uses incoming signal data to automatically set measurement ranges, ensuring more accurate measurements.

Enabling Autorange

1. To enable autorange mode for an SMU or VPS device, click the **Measurement Autorange** toggle within the device panel and ensure it is in the **On** position.

2. **Optional:** Use the device panel to [configure autorange settings](#).
3. **Optional:** To disable autorange, click the **Measurement Autorange** toggle again and ensure it is in the **Off** position.

Configuring Autorange

Use the following controls in the SMU or VPS device panel to specify how you want autorange to respond to incoming signals from your device.



Note [Autorange mode must be enabled](#) to access these settings in your device panel.

- **Aperture time mode** — Specifies whether the aperture time used for measurement autorange is determined automatically or customized using the value specified by the **Minimum aperture time** setting.
- **Minimum aperture time** — Specifies the aperture time used by the measurement autorange algorithm.



Note This is a minimum value, and will be scaled up to optimize the algorithm for different ranges. For smaller ranges, the value will be scaled up to account for signal noise.

- **Minimum aperture time units** — Specifies the units of the **Minimum aperture time** setting. Aperture time can be specified in seconds or power line cycles (PLCs).
- **Autorange behavior** — Specifies the algorithm the hardware uses for measurement autoranging. Choose from the following behaviors.
 - **Range up to limit then down** — go to range limit the range down until measured value is within thresholds.
 - **Range up** — go up one range when upper threshold is reached.
 - **Range up and down** — go up or down one range when the upper or lower threshold is reached.
- **Minimum current range** — Specifies the lowest range used during measurement autoranging.



Note Limiting the lowest range can improve the speed of autoranging and minimize thrashing between ranges when measuring a noisy signal.

NI-DCPower Independent Channel Sessions

InstrumentStudio creates a single multi-channel session for all devices in a single SMU device by default.



Note This is not default behavior in [some versions of InstrumentStudio](#).

Considerations when configuring sessions with SMU devices

Using independent channels allows you to configure multiple channels of the same instrument, or multiple instruments, within the same session independently of one another. InstrumentStudio exports a single session configuration for all channels by default. In certain cases, you must change your session type to `Single channel (compatibility)` mode.



Note To manually select the session type you want to use, open the instrument header menu (⚙️) of the device in your panel, and click **Session Type**.

You should select **Session Type** » **Single channel (compatibility)** when:

- Exporting a session to platforms which do not support NI-DCPower independent channel sessions. These include Python, LabWindows/CVI, LabVIEW NXG, and Linux desktop.
- Exporting a session to NI-DCPower version 20.5 and earlier.
- Exporting the session to end-user code which uses deprecated NI-DCPower Initialize Functions in C/LabVIEW or deprecated constructors in .NET.







Note Exports from sessions created in InstrumentStudio with independent channels cannot be imported into sessions created with single channels. To verify your session channel configuration, go to the **instrument header** menu (⚙️) and click **Session Type**.

Output Status

You can determine the current output status of non-idle channels with the output status icon, located at the top of the Channels section of an SMU/Power Supply panel.

Table 2. SMU/Power Supply Channel Output Status

Icon	Status	Description
	Generating Output	One or more channels in the panel are sourcing voltage or current.
	Not Generating Output	No channels in the panel are sourcing voltage or current.
	Waiting for Trigger	Channels in the panel are waiting until the trigger condition has been met to start an operation.
	Unknown Status	The output status of the channel(s) in the panel is unknown. Run the panel to refresh the output status.



Note Output continues when closing a panel.

Configuring SourceAdapt Parameters to Measure Transients

You can use SourceAdapt technology to customize the source measure unit (SMU) response to any load. For more information on National Instruments' SourceAdapt technology, refer to [NI SourceAdapt Next-Generation SMU Technology](https://www.ni.com/whitepapers/ni-sourceadapt-next-generation-smu-technology) on ni.com.



Note Not all SMUs support SourceAdapt technology. Refer to the documentation for your SMU to see whether the SMU supports SourceAdapt.

Selecting a SourceAdapt Preset

1. Place a SourceAdapt-compatible SMU in the large panel.

2. Place the SMU panel into [Waveform mode](#).
3. Open the Channel Settings window.
4. Scroll down to the SourceAdapt tuning parameters section of the Channel Settings window.
5. Select a SourceAdapt preset from the list:
 - **Slow**—Slows the control loop for a more stable response.
 - **Normal**—The default SourceAdapt preset, a balance between speed and stability.
 - **Fast**—Speeds up the control loop for a faster response.
6. (Optional) Make custom adjustments to the response using the fields in the SourceAdapt tuning parameters section.

Configuring Sequences

You can change the channel operating mode of an SMU/Power Supply channel to Voltage Sequence or Current Sequence mode to enable power sequencing. Power sequencing allows you to output the desired power-up sequence for a DUT with multiple power sources by configuring the order, timing, and level of each power supply channel.



Note

- Channels within the same panel operating in Voltage Sequence, Current Sequence, Pulse Voltage, or Pulse Current mode are automatically hardware-synchronized. Refer to [Multi-Device Synchronization](#) for more information on hardware and software synchronization within panels.
- Sequence channel operating modes are supported only on power supplies that support advanced sequencing. For more information on advanced sequencing and supported devices, refer to [NI-DCPower Advanced Sequencing](#) documentation.

1. Place an SMU or power supply in a panel.
If you place the device in a large panel, the graph shows a preview of the output sequence the channel will generate.
2. Set the [operating mode](#) of the panel to **Waveform** or **Charting**.

Placing the panel in **Waveform** mode enables fast sampling and allows you to visualize the sequence in more detail.

3. Set the channel operating mode to **Voltage sequence** or **Current sequence**. A step table appears within the channel.
4. Edit the steps in the step table by entering the values manually, importing data from a file, or pasting data from the clipboard.
5. (Optional) Tune the output of the sequence using [SourceAdapt](#) parameters, found in the Channel Settings window.
6. Enable the channel output and run the panel to begin the sequence.

Waveform Generators

Refer to the following sections for information about setting up a waveform generator instrument in InstrumentStudio.

Generating Waveforms with a Waveform Generator

Use a waveform generator to monitor and configure waveforms in InstrumentStudio.

1. [Add a waveform generator device](#) to the large panel.
2. Select a [waveform mode](#) from the drop-down menu in the upper-right corner of the large panel.
 - Standard waveform—Generates a waveform using the channel settings you specify.
 - Arbitrary waveform—Generates a waveform using settings specified in a waveform file and any additional channel settings you specify.
3. Specify the type of waveform to generate.
 - If you are generating a standard waveform, select the waveform type using the **Waveform** drop-down menu.



Note If you select a **User-defined** waveform, you must load a waveform file. User-defined waveform files must be in CSV format, with the exact number of samples listed in your device's specifications document. For example, the PXIe-5433 requires 8192 samples for a user-defined waveform. The waveform samples may be in a single row or single column.

- If you are generating an arbitrary waveform, load a waveform file using the **Filename** field. The waveform file specifies the type of waveform to generate.



Note Arbitrary waveform files must be in CSV format or binary format:

- CSV—For single-channel instruments, waveform samples must be in a single row or a single column. For two-channel instruments, each channel's waveform samples must be in a separate column.
- Binary—For single-channel instruments, waveform samples may be 8-byte double-precision or 2-byte half-precision floating point, and the byte order may be little-endian or big-endian. For two-channel instruments, both channels' samples must be interleaved.

4. [Configure waveform channel settings](#) using either the controls on the large panel or the large panel's Channel Settings window. Customizable settings change depending on the waveform mode and type you select.



Note If you are generating an arbitrary waveform, you must select a triggering mode for the waveform using the **Mode** setting. For more information on arbitrary waveform trigger modes, refer to [Advanced Waveform Sequencing and Triggering on Arbitrary Waveform Generators](#) at ni.com.

5. Select **Run**.
The waveform generates with the settings you specified.

Custom Waveform Channels and Triggers

Use the following settings to configure channels, triggers, and other parameters of the waveform generator.

Waveform Channel Settings

- Output Impedance—Sets the output impedance value to either 50 Ω or 75 Ω .
- Load Impedance—Sets the load impedance value to one of the following settings:
 - **Match output**—Matches the load impedance to the output impedance.

- **High-Z**—Sets the load impedance to high impedance.
- **Custom**—Sets the load impedance to a custom value, in ohms.
- **Digital Filter**—Enables or disables the digital filter. The digital filter increases the effective sampling rate by providing points that interpolate between generated samples.
- **Analog Filter**—Enables or disables the analog filter. The analog filter is applied after the interpolated signal, and, when combined with the digital filter, can remove high-frequency images from the frequency domain.
- **Terminal config.**—Returns the terminal configuration for the waveform generator. Most waveform generators support only one option (differential or single-ended).

Waveform General Settings

- **Waveform**—Sets the type of waveform to generate if you are generating a standard waveform.



Note

- If you select **User-defined**, you must load a waveform file. User-defined waveform file must be in CSV format.
- Different waveform types have different configurable settings.

- **Sample Rate**—Sets the sample rate of an arbitrary waveform.

Waveform Trigger Settings

- **Trigger Mode**—Sets the mode for triggering arbitrary waveform generation.



Note For more information on arbitrary waveform trigger modes, refer to [Advanced Waveform Sequencing and Triggering on Arbitrary Waveform Generators](#) at ni.com.

- **Trigger Type**—Sets the trigger type to one of the following values:
 - **Immediate**—Triggers waveform generation as soon as you run the waveform generator.
 - **Software**—Triggers waveform generation according to settings in an external application.
 - **Digital edge**—Triggers waveform generation on the rising edge of a specified source terminal. The source terminal must export a signal to use digital edge

triggering.

Hardware Event Output Terminals

These settings determine to which chassis terminal(s) hardware events are exported.

Waveform Modes

You can generate a waveform using one of the following two modes:

- **Standard Waveform**—Outputs waveforms according to the channel settings you specify in InstrumentStudio or an external application. Using a standard waveform allows you to generate several different standard waveform types (sine, square, etc.) at precise frequencies.



Note The user-defined standard waveform type allows you to generate a periodic waveform with a finite, specified number of points using Direct Digital Synthesis (DDS). To generate a user-defined waveform of any size, use Arbitrary Waveform mode.

You can also change the output waveform frequency of a standard waveform during generation with a short response time. You can also use the Sweep operating mode to configure a range of frequencies to generate over a specified number of steps and time duration, or use the List operating mode to configure a sequence of frequencies to generate for specified durations.

- **Arbitrary Waveform**—Outputs waveforms according to the settings specified in an external file. Using an arbitrary waveform allows you to define large, complex waveforms using a waveform settings file. While you can generate more complex waveforms using an arbitrary waveform, changes to arbitrary waveform settings have a longer response time than standard waveforms.

Waveform Generator Status

A waveform generator channel can be in one of the following states:

- **Stopped**—Waveform generation is stopped on this channel.
- **Running**—Waveform generation is running on this channel.
- **Waiting for trigger**—Waveform generation is waiting until the trigger condition has

been met.



Note Generation stops when closing a panel.

Exporting Configurations

Refer to the following sections for information about exporting instrument and device configurations for use with other NI products.

Exporting a Device Configuration

Once you have configured a device in InstrumentStudio, you can export the device's settings to a device configuration file, which can then be imported to LabVIEW or another application to apply the device configuration to a different session.



Note

- You cannot import a device configuration file into InstrumentStudio. If you would like to save a layout or device configuration for future use in InstrumentStudio, you can either save the entire project (**File » Save all**) or an individual device's soft front panel (**File » Save [device name].sfp**).
- The following waveform modes are not supported when exporting a configuration that includes a waveform generator:
 - List and Sweep mode
 - Arbitrary waveform mode with a .CSV waveform type
 - User-defined waveform mode

To export a device configuration, complete the following steps:

1. Configure the device's settings.
2. Open the instrument header menu and select **Export » Driver configuration...**
3. Select the location to save the configuration file.

The device configuration file is saved to the location you specified.

To apply device settings from a device configuration file to a device session in LabVIEW, you must first import the device configuration file to LabVIEW using a driver-specific LabVIEW VI called Import Attribute Configuration. Each driver has its own implementation of Import Attribute Configuration. Refer to the driver's documentation for more information:

Device Driver	Import Configuration VI
NI-SCOPE	NI-SCOPE Import Attribute Configuration File
NI-DCPower	NI-DCPower Import Attribute Configuration File
NI-DMM	NI-DMM Import Attribute Configuration File
NI-FGEN	NI-FGEN Import Attribute Configuration File

Related concepts:

- [Configuring Panels with the Instrument Header Menu](#)

Exporting Configurations to TestStand

Exporting configurations saves time when automating test sequences in TestStand. Once you configure your hardware in InstrumentStudio, you can export your configuration for use in TestStand sequences. You can export device and panel configurations to recent and supported 64-bit versions of TestStand. You can then use these configurations with LabVIEW, C#, C, or CVI automation code in a TestStand sequence.


Refer to the following topics for more information on exporting device and panel configurations:

- [Exporting an InstrumentStudio Configuration](#)
- [Inserting an InstrumentStudio Configuration in a TestStand Sequence](#)
- [Editing an Exported Configuration](#)

Exporting an InstrumentStudio Configuration

Before you export an InstrumentStudio configuration to TestStand, ensure that the following conditions are met:

- Use a recent and supported 64-bit version of TestStand.
- Instrument channels that you want to include in the export are not set to idle, because idle instrument channels are not exported to TestStand.
- Select a specific site in the site filter, or select the **System pins** option to only export system pins. You cannot export an InstrumentStudio configuration if you select the **All sites** option in the site filter.

1. From the top toolbar or the instrument header menu, select the **Export to TestStand** button ().



Note If the **Export to TestStand** () button does not appear, ensure that you have a recent and supported version of TestStand installed.

2. Specify a name for the exported configuration. You can configure the default format of the TestStand export name by selecting **File » Preferences** and navigating to the Export to TestStand section.
InstrumentStudio creates an IO Configuration file, which contains both the driver configuration and the panel layout from InstrumentStudio.

Inserting an InstrumentStudio Configuration in a TestStand Sequence

When you insert an IO Configuration file into a TestStand sequence, TestStand creates a copy of the configuration file in the step you specify. When you run the sequence, the step creates sessions for the InstrumentStudio-configured instruments and applies the configuration to the new sessions.

These created sessions are automatically stored in local variables in TestStand. You can then pass the session from the variable to automation code in Action steps, apply a new configuration to the existing session using the variable, or use the session in a [Sweep loop](#) to configure the sequence of values for certain attribute in each instrument.



Note For more information on using TestStand, refer to [TestStand documentation](#) on ni.com.

Editing an Exported Configuration

You can edit an exported configuration in a specific TestStand step. Complete the following steps to edit an exported configuration from TestStand:

1. Import an InstrumentStudio configuration to TestStand.
2. Navigate to the TestStand step you would like to edit and select **Edit**.
InstrumentStudio opens in Edit mode and displays the instrument panels in the same layout as the document you exported the configuration from.
3. Edit the configuration in InstrumentStudio.
4. Click **OK**. Any changes you made to the configuration commit back to the TestStand step or IO Configuration file you edited.

Capturing Data


Using InstrumentStudio, you can capture data from an entire layout or a single panel. You can also take a screenshot without capturing data.

Adjust data capture preferences by selecting **File » Preferences** and navigating to the Capture data tab. You can perform the following actions on this tab:


- Setting the destination directory
- Changing the filename for images and data
- Changing the file format for images and data

By default, images are captured in the PNG format. Data is captured in the NI-TDMS format, but you can also capture data in the CSV format.


Capturing Data from a Layout

Capture data from an entire layout by selecting the **Capture data** icon () from the document toolbar, located just above the large panel. InstrumentStudio saves a timestamped screenshot and a data file to the destination directory. The screenshot contains the view of the entire layout at the time data was captured. The data file contains detailed information about every device in the layout.

Capturing Data from a Panel

Capture data from a single panel by opening the instrument header menu () and selecting **Capture data**. InstrumentStudio saves a timestamped screenshot and a data file to the destination directory. The screenshot contains the view of the panel at the time data was captured. The data file contains detailed information about the device or devices in the panel.

Capturing a Separate Screenshot

If you want to capture a screenshot but not a data file, select the **Capture screenshot** icon () from the document toolbar, located just above the large panel. InstrumentStudio attaches the screenshot to the clipboard.

Parsing Captured Data

Parse NI-TDMS data files using LabVIEW, LabWindows/CVI, DIAdem, VeriStand, or one of several third-party applications. For more information on using the NI-TDMS file format, visit ni.com/info and enter the Info Code `tdmsfileformat`.

Parse CSV files using a spreadsheet application for best results. CSV files sort channel, device, and measurement type into columns. Individual measurements and statistics, including mean, range, and standard deviation, are sorted into rows.

Related concepts:

- [Configuring Panels with the Instrument Header Menu](#)

Sequencer Tool

The sequencer tool enables you to perform a series of ordered tasks using instrument panels and measurement plug-ins. Automating using the sequencer tool can enable you to efficiently perform multi-step measurements, saving time and ensuring consistency.



Note This feature is only available with an InstrumentStudio Professional license.

Related information:

- [Measurement Plug-In User Manual](#)

Supported Instruments

The sequencer tool supports certain instrument types and supports specific operations for each instrument type.

Instrument Panel Type	Start	Read	Stop
Digital Multimeter	✓	✓	✓
Waveform Generator	✓		✓
Oscilloscope	✓	✓	
SMU/Power Supply	✓	✓	✓
SCPI Instrument		✓	
RF Signal Analyzer	✓	✓	
RF Signal Generator	✓		✓
Network Analyzer	✓	✓	

Accessing the Sequencer Tool

Complete the following steps to access the sequencer tool in InstrumentStudio.

1. **Required:** Make sure you have activated your InstrumentStudio Professional license to use the sequencer tool.
2. Click the Sequencer pane at the top of the project window.

Building a Sequence

Complete the following steps to create a new sequence step.

Before you begin, make sure to save your current project.



Note You cannot use the Sequencer Tool within an unsaved project.

1. Navigate to the panel you want to add to a sequence.
2. Click the **Add to sequence** button.



Tip You can hover over **Add to sequence** to see a list of all associated steps that contain the selected panel.

To ensure the correct steps have been added to the sequence, open the Sequencer pane and check the list of steps displayed within the **Step list** view.

Sweeps

Sweeps enable you to repeat selected steps within a sequence and increment the values of parameters across the individual measurement steps within the sweep.

Adding a Sweep Loop to a Sequence

To add a sweep loop to a sequence, click the add step button (+) for the steps you want to sweep and select **Sweep loop**.

Sweep Behavior

When you execute a sequence that contains a sweep within your InstrumentStudio project, the sequence executes the steps within the sweep loop based on the parameter settings you select when configuring the sweep. In general, the sweep

executes once for each new parameter value specified in the sweep settings.

For example, if you wanted to run a test sequence that sends a series of three different voltages to a device using an SMU panel, and then reads data back from the device using a DMM panel, the sequence executes in the following order:

- Sweep 1, Step 1, Parameter Value 1: `SMU[Start]` sends 1.15 V to device.
- Sweep 1, Step 2: DMM reads output from device.
- Sweep 1, Step 3: `SMU[Stop]`
- Sweep 2, Step 1, Parameter Value 2: SMU sends 1.35 V to device.
- Sweep 2, Step 2: DMM reads output from device.
- Sweep 2, Step 3: `SMU[Stop]`
- Sweep 3, Step 1, Parameter Value 3: SMU sends 1.5 V to device.
- Sweep 3, Step 2: DMM reads output from device.
- Sweep 3, Step 3: `SMU[Stop]`

Once a sweep loop has completed, the following steps of the sequence execute.

Sweep Strategies

You can configure sweep loop behavior by opening the step settings panel (⚙️). The following sweep strategies are available in the Sequencer tool:

- **Start, Stop, Step**—Specify a start value and stop value, as well as the step size to use.
- **Start, Stop, Count**—Specify a start value and stop value, as well as the amount of steps to use within that range.
- **Array**—Manually specify a list of values to sweep through.

Sweep Step Settings

The following settings are available within the parameter settings panel. A preview of values is shown for the selected settings.

- **Sweep Name**—The name you want to use for the parameter to be swept.
- **Data Type**—The data type of the parameter. Can be numeric, etc.
- **Strategy**—Which sweep behavior you want to use. Refer to ***Sweep Strategies*** for more information on sweep types.

- **Distribution**—How to distribute steps between the **Start** values and **Stop** values specified for a sweep. Can be linear or geometric.
- **Start**—The initial parameter value to use when performing a sweep.
- **Stop**—The final parameter value to use when performing a sweep.
- **Step**—The step size to use when selecting a **Start, Stop, Step** sweep strategy.
- **Count**—The number of steps to create when selecting a **Start, Stop, Count** sweep strategy.
- **Values**—When using an **Array** sweep strategy, enter the values you want to sweep through using this table. When other strategies are selected, this table displays the values generated by the selected sweep settings.

Configuring Sweep Parameters for Sequence Steps

After configuring the sweep step settings, you can configure how each step within the sweep will handle the sweep parameter. Sweep parameters for steps within a sweep are configured in the step settings. Step settings enable you to use the sweep parameter for any appropriate step inputs. You can select the same sweep parameter on multiple step inputs.

Supported Panel Types

Sweeps are supported for use with measurement plug-in steps and instrument steps.

Modifying a Sequence

Changing Sequencer Panel Configuration

If you change the configuration of a panel that is used in multiple steps, InstrumentStudio applies the changes to all instances of that panel in the sequence.



Note Changes made to panel configurations are applied immediately.

Reusing a Panel

If you want to use different configurations with the same panel, you must create a new panel. Click **Duplicate Panel** (■) to quickly make a duplicate of the selected panel.

Reordering a Sequence

To change the order of a step within a sequence, drag and drop the step to the desired position in the sequence.

Viewing Steps

Double-click a step to quickly access and edit the panel associated with it.

Executing a Sequence

Executing a sequence performs all the steps that are defined in the sequence. Once the sequence has executed, you can view any data measured during the sequence as well as the execution log to ensure the sequence has completed all steps successfully.

Before executing a sequence, make sure all required devices within your system are present, connected, and powered on.

Click **Run** to execute the sequence.

The timer in the sequencer pane starts, which indicates that the sequence is actively executing.



Note Each time InstrumentStudio executes a sequence, InstrumentStudio creates an execution report and saves the report in a folder titled `Sequence Results` within the project folder. Refer to ***Viewing a Sequence Report*** for information on how to view sequence reports.

Viewing a Sequence Execution Log

InstrumentStudio generates an execution log each time it executes a sequence. The execution log lists information about each step that is executed during a sequence. You can use the log to identify which steps executed and to check the status and the execution time of each step.

1. Open the Sequencer pane.
2. Click **Execution log**.

Viewing a Sequence Report

A sequence report is a PDF file detailing the results of a sequence. InstrumentStudio generates a sequence report each time you execute a sequence. Complete the following steps to access a sequence report.

1. Execute a sequence and wait for the sequence to execute.
When the sequence completes, InstrumentStudio generates a report about the sequence.

InstrumentStudio adds sequence execution report files to the **Project Files** pane under the `Sequence Results` folder.

2. Click the **View Report** button.

The generated report opens in the default PDF viewer on your system.

Debugging Programmatic Applications

Use InstrumentStudio's debug mode to monitor and control devices in use by an external application.

You can use InstrumentStudio to troubleshoot devices currently in use by an external application. An external application is any application running outside of InstrumentStudio, including LabVIEW, TestStand, or a C/C++/.NET application.

If you receive unexpected results from a device in an external application, you can monitor the device in InstrumentStudio to assess the issue, troubleshoot the issue by changing the device's settings in InstrumentStudio, then continue with the external application. For example, you can pause the external application where you suspect an error, edit the device settings in InstrumentStudio, then resume the application with the new settings.



Note

- Debugging features are not supported when using sweep mode in an SMU (Source Measure Unit) panel.
- When monitoring a device in debug mode, InstrumentStudio establishes a connection to the device session in the external application, not the device itself. Therefore, InstrumentStudio will only monitor data that is fetched or read from the currently running external application.

Waveform Generator Debug Mode Limitations

When using debug mode with a waveform generator, be aware of the following limitations:

- Debug mode does not support arbitrary sequence or script modes. Controlling arbitrary sequence or script mode sessions is not allowed.
- List mode control is disabled when InstrumentStudio is in monitor or controller mode.

- When InstrumentStudio is in controller mode, you cannot switch to list or sweep mode from another operation mode.
- When InstrumentStudio is in monitor mode, you cannot take control of a panel with a mix of standard and arbitrary waveform channels.

RF Signal Generator Debug Mode Limitations

When using debug mode with an RF signal generator, be aware of the following limitations:

- You cannot take control of an RF signal generator panel if streaming is enabled, or if there is an active configuration list.
- You cannot return to script mode after clicking the **Preset** button.
- Waveform-specific controls are read-only in Script mode.

Related concepts:

- [Configuring Panels with the Instrument Header Menu](#)


Entering Debug Mode

You can enter debug mode from the home screen by selecting **Debug**. With this method, InstrumentStudio searches for open device driver sessions. Then, based on the result of this search, InstrumentStudio creates a new layout. The devices in the newly created layout automatically enter debug mode.

You can also enter debug mode while an InstrumentStudio project is already open. With this method, a device that is in use by an external session automatically enters debug mode in the following cases:

- The device is placed in a layout
- The device is already part of an active layout

Take, for example, a scenario where you run an oscilloscope in an InstrumentStudio panel alongside a LabVIEW application that acquires measurements from that oscilloscope. In this case, the InstrumentStudio panel enters debug mode until the LabVIEW application (the external session using the oscilloscope) closes.

Devices currently in use by an external application display the external session icon () in the Edit Layout window.



Note Debugging is enabled by default. If a device fails to enter debug mode, confirm that debugging is enabled. Open the Configure Debug Session window from the instrument header menu and check the **Debug Enabled** box for the device that you want to debug. If you change settings in the Configure Debug Session window while an external session is open, you must restart the external session to apply the changes.

Related tasks:

- [Enabling Debugging with a C, C++, or .NET Application](#)
- [Disabling Debugging](#)

Enabling Debugging with a C, C++, or .NET Application

Complete the following steps to debug a C, C++, or .NET application using InstrumentStudio.



Note Supporting communication with a device in C, C++, or .NET environments at breakpoints requires additional overhead that may affect performance.

1. Select **Configure debug settings** from the instrument header menu.
2. Select the **Using Breakpoints in C/C++/.NET Applications** checkbox next to the device you want to debug. Click **OK**.
InstrumentStudio enables breakpoints in C, C++, and .NET external applications.
3. Debug the application and/or device.
4. When you finish debugging, deselect the **Using Breakpoints in C/C++/.NET Applications** checkbox in the Configure Device Settings window and restart the external application to apply the changes.

Refer to [Monitoring and Controlling Devices in External Sessions](#) for more information on using debug mode.

Related concepts:

- [Entering Debug Mode](#)
- [Configuring Panels with the Instrument Header Menu](#)

Monitoring and Controlling Devices Used in an External Session

You must enter debug mode to access the **Monitor** and **Control** buttons. Refer to [Entering Debug Mode](#) for more information.

Complete the following steps to monitor and/or control a device in InstrumentStudio when an external application is using the device:

1. Select **Monitor**.

InstrumentStudio obtains read-only access to the external session, and the device's controls are disabled. You are now monitoring the device.

2. Select **Control**.

InstrumentStudio takes control of the device if an external application is not currently accessing the device. If you select **Control** and you are not monitoring any external application sessions or the external application is paused, InstrumentStudio takes ownership of the device.



Note Selecting **Control** takes control of the device only until the next time the external application calls the device, at which point control reverts to the external application and InstrumentStudio returns to monitoring the session. You can use breakpoints to pause the external application, allowing InstrumentStudio to retain control of the device until you have made your changes and you are ready to continue the application.

3. Edit the device settings.

4. Click **Monitor** to return to monitoring the session and revert control of the device to the external session.

The edited device settings are applied to the external session.

Live Measurement View

The following topic contains information about monitoring live device data in InstrumentStudio.

When monitoring a device in debug mode, certain devices will instantly display measurements of channel data, even if external applications are not fetching device data. InstrumentStudio currently supports live data monitoring for the following devices:

<ul style="list-style-type: none"> • PXIe-4135 • PXIe-4136 • PXIe-4137 • PXIe-4138 	<ul style="list-style-type: none"> • PXIe-4139 • PXIe-4140 • PXIe-4141 • PXIe-4142 	<ul style="list-style-type: none"> • PXIe-4143 • PXIe-4144 • PXIe-4145 • PXIe-4147
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Note For devices not listed here, test code must call measure or fetch for measurements to be updated when in monitor mode.

Disabling Debugging

Complete the following steps to disable debugging for a device:

1. Open the Configure Debug Session window by selecting **Configure debug session** from the instrument header menu.
2. Deselect the **Debug Enabled** checkbox to disable debugging for a specific device.
3. Click **OK**.
4. Restart the external application to apply the changes.

Debugging is disabled for the specified device. This device cannot enter debug mode until debugging is enabled again.

Related concepts:

- [Entering Debug Mode](#)

• Measurement Plug-Ins

Measurement plug-ins help you create reusable measurements for any supported device. A measurement plug-in consists of measurement logic and metadata generated in either Python or LabVIEW, and an optional UI. A measurement plug-in runs as a service.



Note • This feature is only available with an InstrumentStudio Professional license.

Refer to the **Measurement Plug-Ins** user manual for more information on developing measurement plug-ins.

Related information:

- [Measurement Plug-Ins Python Examples](#)
- [Measurement Plug-In User Manual](#)

Running a Measurement Plug-In

Complete the following steps to run a measurement plug-in.

1. Open the measurement in InstrumentStudio.
2. On the Home screen, select **Manual Layout**.
The Edit Layout screen appears.
3. Locate your measurement plug-in in the list. Select **Create large panel** in the drop-down list for your measurement plug-in.



Note If your measurement plug-in does not appear in the Edit Layout window, ensure that the plug-in is either configured to start automatically or has been started manually. For more information, refer to **Statically Register a Measurement Service** section of **Developing a Measurement Plug-In with LabVIEW** or **Developing a Measurement Plug-In with Python** in the

Measurement Plug-Ins user manual.

The large panel updates to list the selected measurement plug-in.

4. Click **OK**.

InstrumentStudio opens a new project and displays the measurement UI.

5. **Optional:** Ensure that the project contains any referenced pin map and that a pin map is marked as active.
6. Click **Run** in the measurement UI.



Tip You can change the behavior of the **Run** button so that the measurement runs continuously. Click the arrow at the side of the button and select **Run Continuously** to change the button behavior. Once the measurement is running, the button text changes. Click **Stop** to stop the measurement.

The measurement executes and values update in the measurement UI.

Related information:

- [Measurement Plug-Ins Python Examples](#)

Plug-In Versioning

Refer to the following section for details about using versioned measurement plug-ins.

Versioned Plug-Ins

Refer to **Plug-In Versioning** in the **Measurement Plug-Ins** user manual for information on versioning measurement plug-ins using LabVIEW or Python.

Selecting A Measurement Plug-In Version

When adding a measurement plug-in to your project layout in the Edit Layout or Manual Layout windows, use the version selector dropdown to select the version of the measurement plug-in you want to use. If there is only one available version of a plug-in, the version number will be displayed next to the plug-in.



Note Measurement plug-in versions will be automatically synchronized to match the version stored in your project. You can manually synchronize versions via the settings within your measurement panel (⚙️). Refer to the following section for more information on measurement plug-in synchronization.

Synchronizing Plug-In Versions within a Project

To synchronize the plug-in version used by a measurement panel, open the panel settings (⚙️) and click **Synchronize Version**. This will update the panel to use the latest version of your measurement plug-in.



Note Version synchronization is only applied to the selected measurement panel. If multiple panels are using the same measurement plug-in, you must repeat this process for each panel you want to synchronize.

• Connecting to a Plug-In Library

A **plug-in library** is an HTTP web API that contains services you use to take measurements. Plug-in libraries enable you to share and collaborate across teams. Complete the following steps to connect to a plug-in library.

1. Go to **Edit Layout** » **Add remote host connections**.



Note You can add a plug-in library to your project using Edit Layout mode.

2. Click the **Add** button.
3. Select **Plug-In Library** as the **Host type**.
4. Enter the IP address or hostname and the port number of the plug-in library you want to connect to.
5. Click **OK**.
6. Continue setting up your layout as needed.

Once you have connected to a plug-in library, you can add measurement plug-ins to your InstrumentStudio project. Refer to ***Running a Measurement Plug-In*** for information on running measurements.

Related concepts:

- [Measurement Plug-Ins](#)

InstrumentStudio Plugins

You can use InstrumentStudio to host plugins written in LabVIEW or C#. These plugins run alongside the InstrumentStudio panels used to configure PXI instruments. Plugins have a runtime configuration and an edit-time configuration. When exporting a plugin configuration to TestStand and using it in a step, the runtime configuration is provided to the sequence as a variable. Both of these configurations persist when the project containing them is saved.

Support for Plugins

The following limitations apply when hosting plugins in InstrumentStudio:

- Hosting a plugin created in C# requires Visual Studio 2019 or newer and .NET 6.0.
- Plugins built in older versions of InstrumentStudio (before version 22Q3) are no longer compatible and must be re-built.
- Plugins cannot be created from the **File » New** menu.
- You cannot use MeasurementStudio controls when hosting plugins created in C#.
- When hosting a plugin in InstrumentStudio, you are limited to the following interactions:
 - Saving and loading
 - Resizing the window
 - Pulling out tabs
 - Exporting the session to TestStand
 - Stopping all outputs with LabVIEW plugins

Pin Maps

Pin maps define test instruments and hardware, sites and pins connected to a DUT, and how the test instruments and hardware connect to DUT pins for each test site. InstrumentStudio preserves mappings created in TestStand Semiconductor Module (TSM) pin maps.


Refer to the other topics in this section of the manual for specific information on how to use and modify pin maps in InstrumentStudio.

Setting an Active Project Pin Map


Set an active pin map to filter your view of connected sites, pins, and devices within your test system in InstrumentStudio.

- 1. Open your InstrumentStudio project.
- 2. Decide how you want to add a pin map to your project.

Option	Description
Create a new pin map	Use the Pin Map Editor to create a new pin map for your project.
Set a default pin map	Automatically add a selected pin map to new InstrumentStudio projects and set it as the active pin map.
Add a pin map file to your project files	Select File » New » Pin Map to add a pin map file (.pinmap) to your project.



Note InstrumentStudio automatically sets the first pin map file you add as the active project pin map. The name of the active project pin map appears in bold in the project files pane.



Note Only one pin map can be active within a project.

- 3. Confirm that the pin map is valid. An error icon will appear next to the pin map file

in the project files pane if InstrumentStudio detects a problem with it. Refer to [Pin Map Errors and Warnings](#) for more information.

4. Activate the pin map. Right-click the pin map file in the project files pane and select **Make active**.
5. Apply [site filtering](#) to view site pins in your panels.
6. Apply [pin filtering](#) to view selected pins within a site in your panels.

To deactivate the pin map, right-click the active pin map in the project files pane and select **Make inactive**.



Note When you launch InstrumentStudio within TestStand Semiconductor Module (TSM), InstrumentStudio automatically uses the pin map configured in TSM.

Selecting a Default Pin Map

Choose a default pin map to add the selected pin map to all new projects created in InstrumentStudio.

1. Go to **File » Preferences » Pin and site mapping**.
2. Click the **browse** button to open the **Default pin map file** dialog and select a pin map file.
3. To remove the default pin map preference, return to the Preferences menu, go to the Pin and site mapping section, and click the **Clear** button to remove the default pin map.

InstrumentStudio will add the default pin map to project files when creating a new project, and automatically use the default pin map as the active project pin map.

Creating a New Pin Map

Use the Pin Map Editor to create new pin maps in InstrumentStudio.

1. Select **File » New » Pin Map** or click **Add** in the project files pane toolbar to create a new pin map file (.pinmap).
2. Use the Pin Map Editor to configure your pin mappings. The Pin Map tab displays mappable items. Use the left pane to browse through and configure the mappings

you want to include in your pin map. To manually edit the pin map file text, click the **XML** tab.



Note If you are working in an unsaved project, InstrumentStudio will prompt you to save the project before creating a new pin map.

3. Click **OK** to close the editor and return to your project. The new pin map is now the active project pin map.

Adding Pin Map Files to a Project

Add existing pin map files to your project to use pin maps you create outside of InstrumentStudio.

1. Select **File » New » Pin Map**.
2. Select a pin map file (.pinmap).
3. Click **OK** to add the file to your project.
4. **Optional:** To open the Pin Map Editor and update the pin map, double-click the file in the project files pane.

InstrumentStudio will automatically make the first pin map file added to a project the active pin map for that project. To activate another pin map, right click it in the project files pane and select **Make active**.

Editing a Pin Map

Use the Pin Map Editor to make changes to a project pin map.

1. Double-click a pin map (.pinmap) in the project files pane to open the Pin Map Editor.
2. Make the desired changes to your instruments, connections, and pins. Use the Pin map tab to view mappable items and change mappings. To manually change the pin map file, click the **XML** tab and to edit the pin map.

When you have completed your edits, click **OK** to close the Pin Map Editor.

Using the Site Filter

After setting an active pin map in InstrumentStudio, devices in your panel appear as pins grouped by sites, system pins, and unmapped channels. Use the site filter in the document toolbar to display pins from a selected site.

1. In your instrument panel, click the **site filter** drop-down in the toolbar at the top of the document window.
2. Select a site from the list to filter the view in the panel to the selected site.



Note

- You must select **All sites** in the site filter to view unmapped channels. Site filtering does not apply to RF signal generators because each device channel can be mapped to multiple pins on multiple sites. You must select sites and pins in the RF signal generator panel settings (...).



Note You cannot export an InstrumentStudio configuration to TestStand while the site filter is set to "All sites". Select a specific site in the site filter, or select "System pins" to only export system pins.

Related tasks:


- [Applying a Pin Filter](#)
- [Exporting an InstrumentStudio Configuration](#)
- [Applying a Pin Filter](#)

Applying a Pin Filter

Use a pin filter to select site and system pins to view in an instrument panel.

Before applying pin filtering, you must select an [active project pin map](#).

Pin maps often contain many pins. Pin filtering enables you to view selected pins to improve navigating within a panel.

1. Click the pin filter button () within your device or instrument panel.
2. Enable the pins you want to view in your panel.
3. Click **OK**.

Your panels will now display configuration settings for pins selected in the pin filter, and measurement panels will display measurements for those pins. Information about hidden and non-idle pins appears underneath the Pins section of the panel.



Note Non-idle pins are pins that are not visible within the filtered view, but are still active.



Note The pin filter state is saved in the instrument panel, and will be restored when the panel is re-opened.

Pin Map Errors and Warnings

InstrumentStudio highlights errors and warnings in project pin map files (`.pinmap`).

Error and Warning Behavior

Common causes of pin map errors and warnings include improperly formatted pin map files, and pin map settings that do not correspond to configurations within your test system.

To determine the cause of the error, double-click the pin map file to open the Pin Map Editor. The dialog will display a message with specific information about the cause of the error or warning. Refer to the following table for information on pin map errors and warnings.

Notification Type	Expected Behavior
Error	Panels will not work using the selected pin map. InstrumentStudio reverts to using the default instrument and channel views. You must address the error before using the pin map file.
Warning	You can use the pin map, but errors may occur at run time. Determine the source of the warning and make the necessary corrections using the Pin Map Editor before run

Notification Type	Expected Behavior
	time.

For detailed information on pin map files, refer to [Pin Map XML File Structure](#).

Enabling Preview Features

Preview features are new features in InstrumentStudio that support specific workflows. They are not release-quality features, and may have functionality gaps. They are only supported for specific uses. You must enable preview features in the InstrumentStudio settings menu to use them.

Follow the steps below to enable preview features.

1. Go to **File » Preferences » Preview Features**.



Note This menu is only visible if a preview feature is available.

2. Click the toggle to enable the desired preview features.
3. Close the **Preferences** panel.

Once you have selected the preview features you want to enable, you must restart InstrumentStudio.